
Theory and Design of Switching Power Inductors for Electromagnetic Interference Assessment and Suppression in Power Electronics Systems

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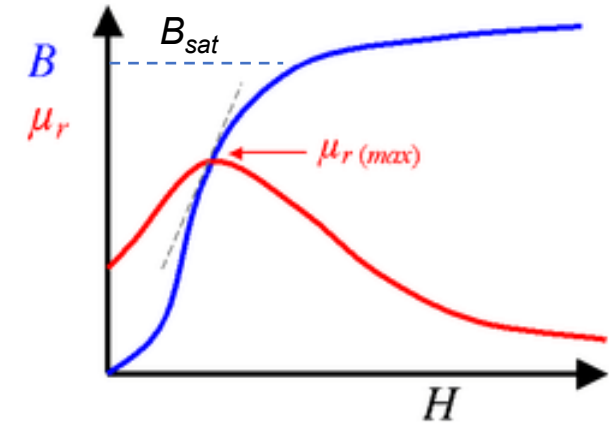
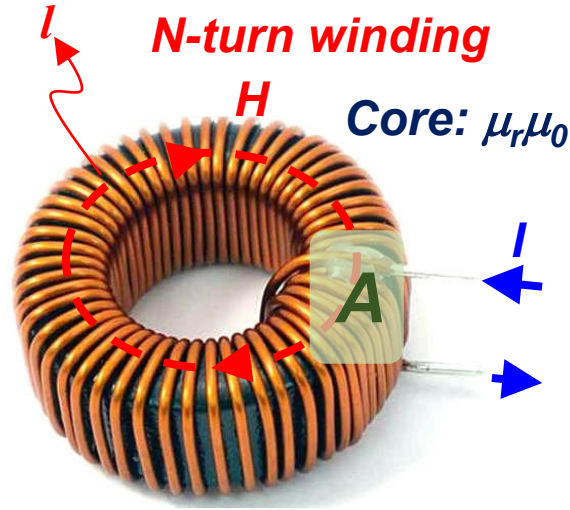
University of Florida

Aug. 2023

1. Power Inductor Basics

Toroidal Power Inductor

Low Permeability Material
w/o Air Gaps:



Magnetic Field Intensity H: $H = \frac{NI}{l}, B = \mu_r \mu_0 H < B_{sat}$

Inductance: $L = \frac{\mu_r \mu_0 A}{l} N^2$

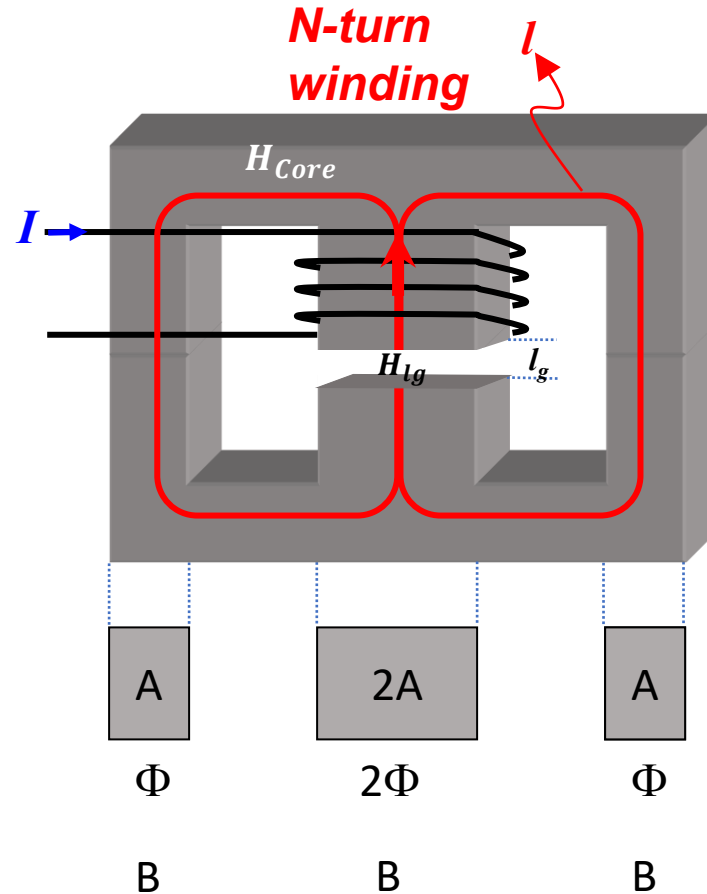
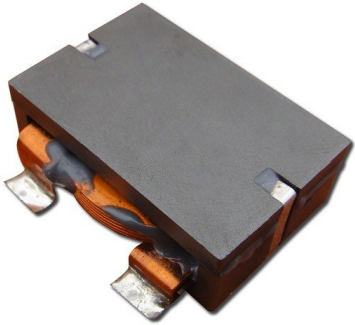
Core Volume: $V = Al$

Magnetic Energy: $E_M = \int_v \frac{1}{2} \mu_r \mu_0 H^2 dv = \frac{1}{2} \mu_r \mu_0 \left(\frac{NI}{l} \right)^2 Al = \frac{1}{2} LI^2$



EE Core Power Inductor

High Permeability Material w/ Air Gaps:



Air gap is used to store energy and prevent saturation

$$B < B_{sat}$$

Magnetic Field Intensity:

$$2\Phi = 2BA = 2\mu_r\mu_0H_{Core}A = 2\mu_0H_{lg}A,$$

$$NI = H_{Core}l + H_{lg}l_g \approx H_{lg}l_g$$

$$H_{lg} = \frac{\mu_r NI}{l + \mu_r l_g} \gg H_{Core} = \frac{NI}{l + \mu_r l_g}$$

Magnetic Energy:

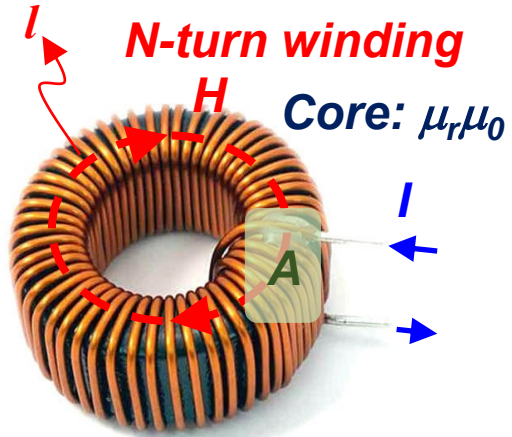
$$E_M = \frac{1}{2} LI^2 = \frac{\mu_0}{2} \int_v (\mu_r H_{Core}^2 + H_{lg}^2) dv$$

$$\approx \frac{\mu_0}{2} \left(\frac{\mu_r NI}{l + \mu_r l_g} \right)^2 2Al_g$$

Inductance:

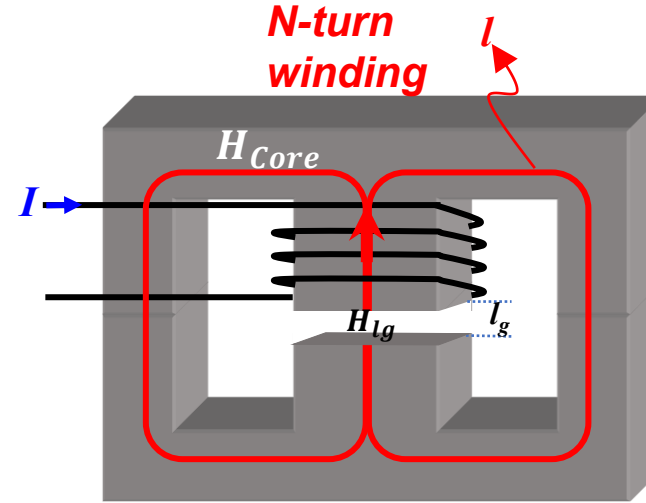
$$L \approx \mu_0 \left(\frac{N}{l / \mu_r + l_g} \right)^2 2Al_g \approx \frac{2\mu_0 A}{l_g} N^2$$

Core saturation constraint:



$$\left\{ \begin{array}{l} \mu_r \mu_0 \frac{NI_{\max}}{l} < B_{\text{sat}} \\ L = \frac{\mu_r \mu_0 A}{l} N^2 \end{array} \right\}$$

$$\Rightarrow I_{\max} \sqrt{\frac{\mu_r \mu_0 L}{V}} < B_{\text{sat}}$$



$$\left\{ \begin{array}{l} \frac{\mu_0 NI_{\max}}{l_g} < B_{\text{sat}} \\ L \approx \frac{2\mu_0 A}{l_g} N^2 \end{array} \right\}$$

$$\Rightarrow I_{\max} \sqrt{\frac{\mu_0 L}{V_g}} < B_{\text{sat}}$$

Winding power loss constraint (winding power loss due to eddy currents induced by the magnetic flux of air gap is not included):

$$P_w = I_{DC}^2 R_{DC} + \sum_{n=1}^{\infty} I_n^2 R_n < P_{w_max}$$

- If the DC current is dominant

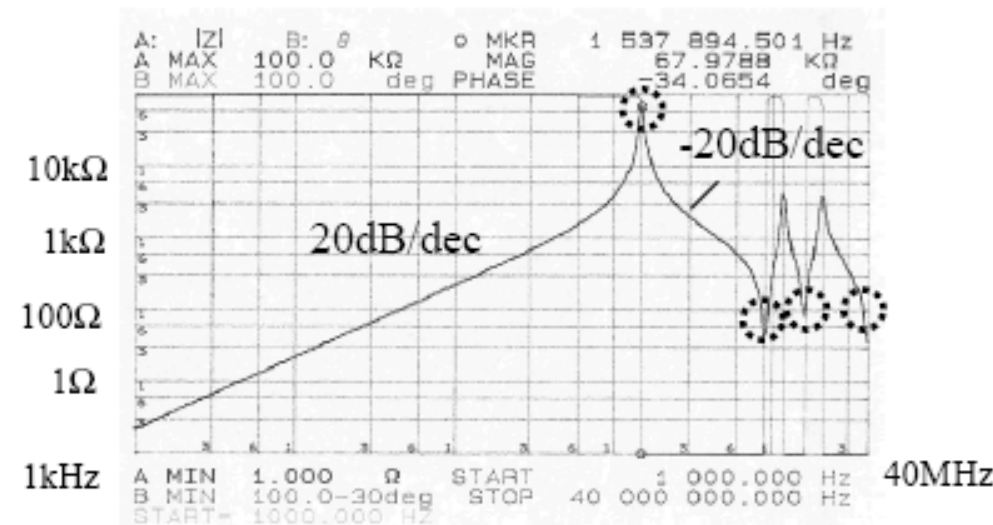
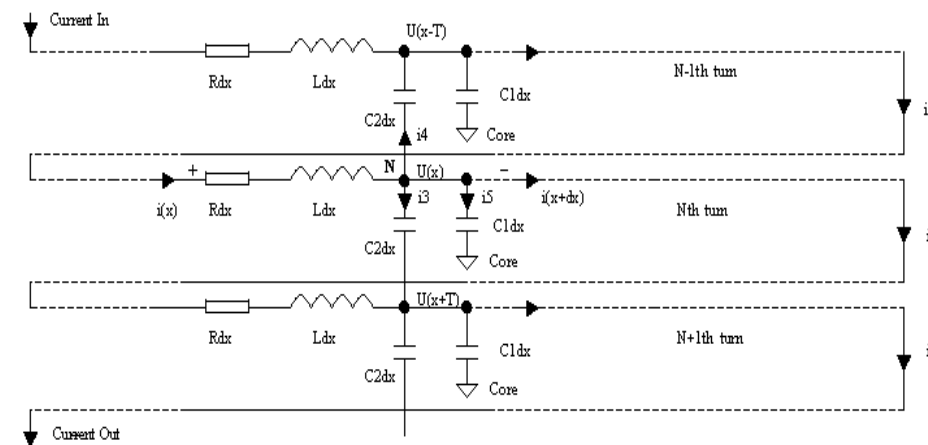
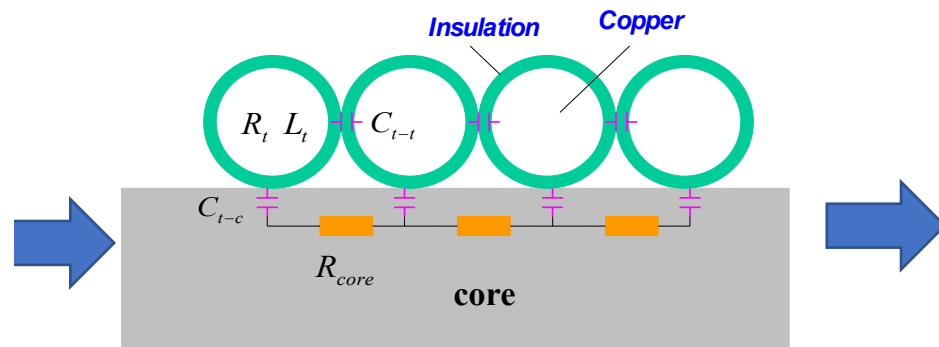
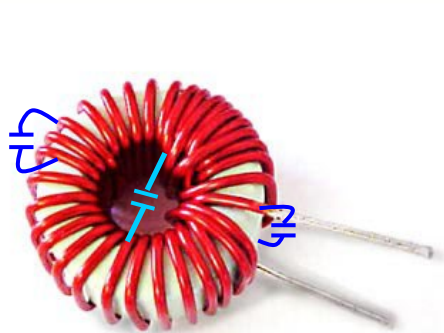
$$P_w = I_{DC}^2 \rho \frac{Nl_T}{A_w} < P_{w_max} \Rightarrow A_w > I_{DC}^2 \rho \frac{Nl_T}{P_{w_max}}$$

- If AC current is dominant

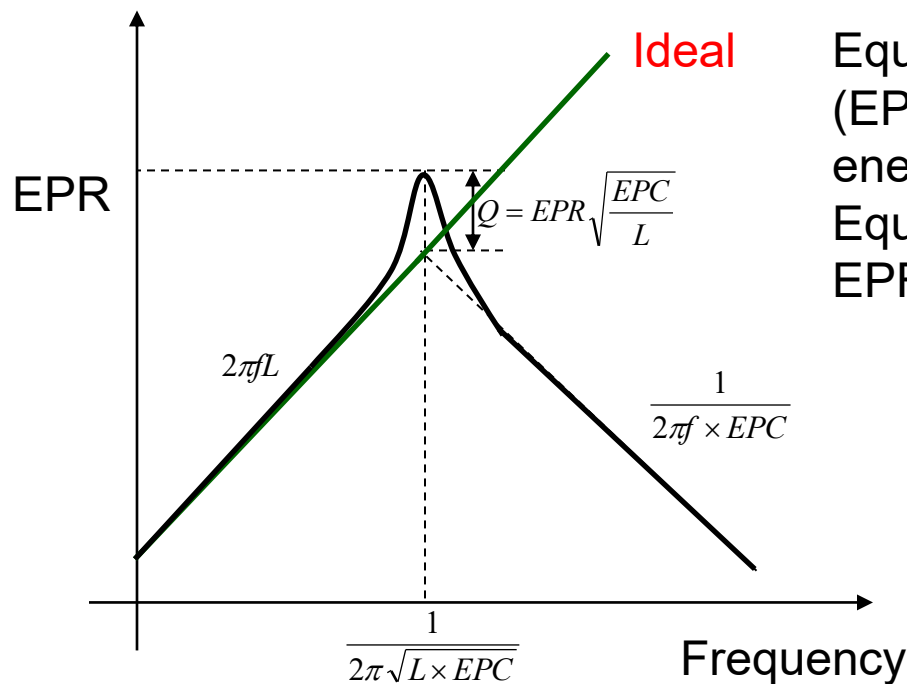
$$P_w = \sum_{n=1}^{\infty} I_n^2 R_n < P_{w_max}$$

(Usually, the fundamental is dominant)

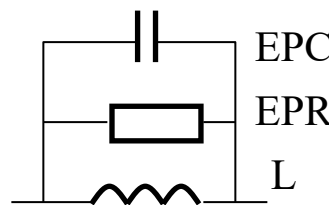
Inductor's 1st order Self-parasitic Model



Impedance Z



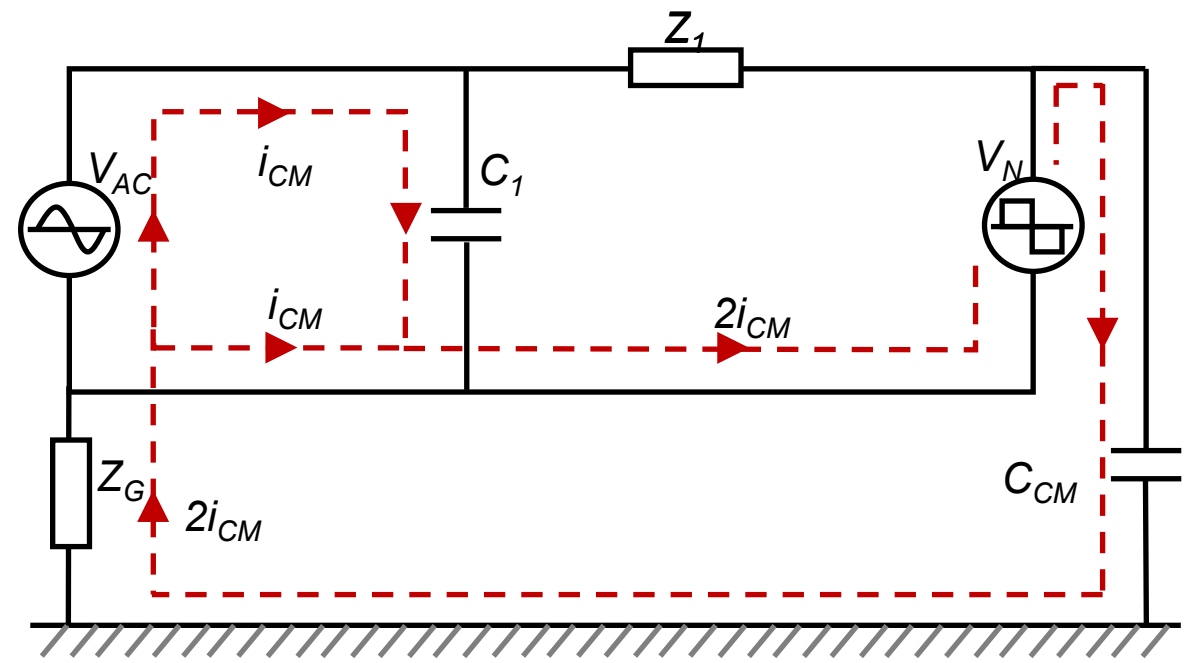
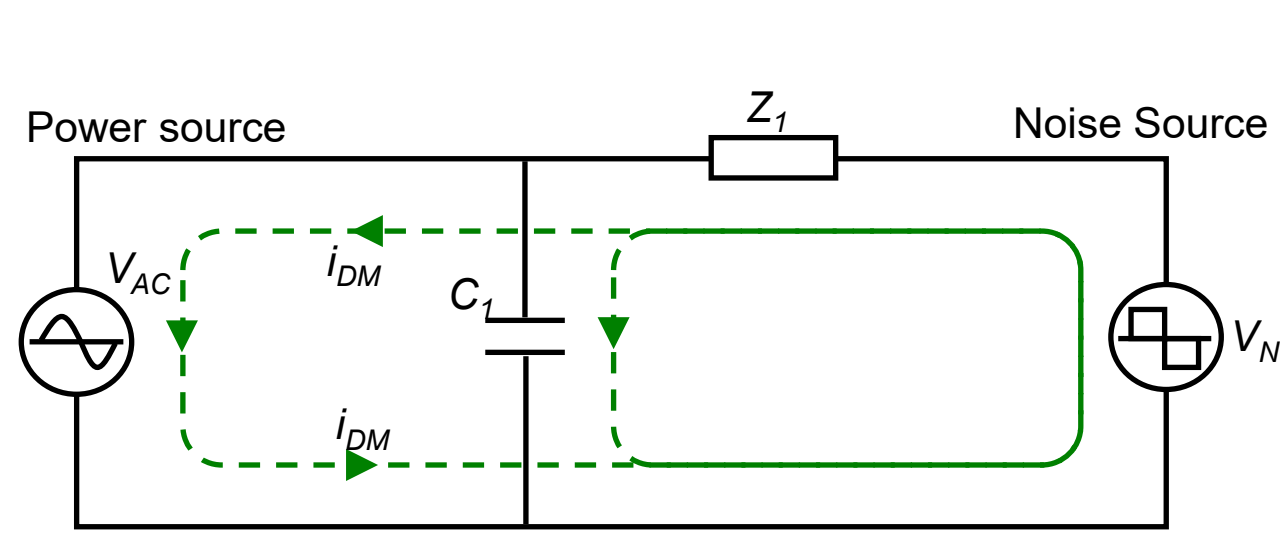
Equivalent parallel capacitance (EPC) represents the electric energy
 Equivalent parallel resistance EPR represents the power loss



1st order approximation

2.1 DM and CM Conductive EMI in Power Electronics Systems

Differential Mode (DM) and Common Mode (CM) Currents



Differential mode (DM) current:

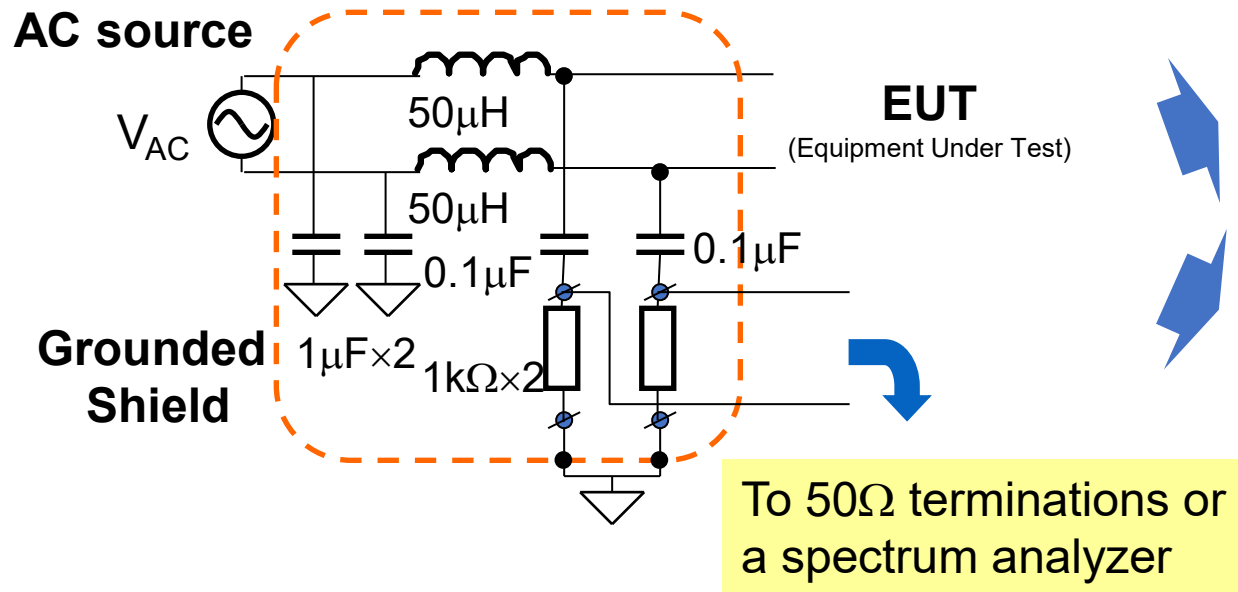
The current flowing between two power delivery paths

Common mode (CM) current:

The current flowing between two power delivery paths and the reference ground

Line Impedance Stabilization Networks (LISNs)

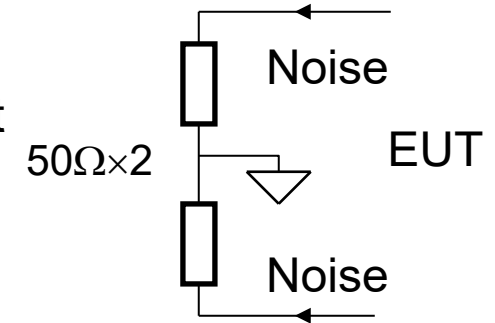
One pair for single phase EMI measurement



Equivalent circuit for AC(50/60Hz)

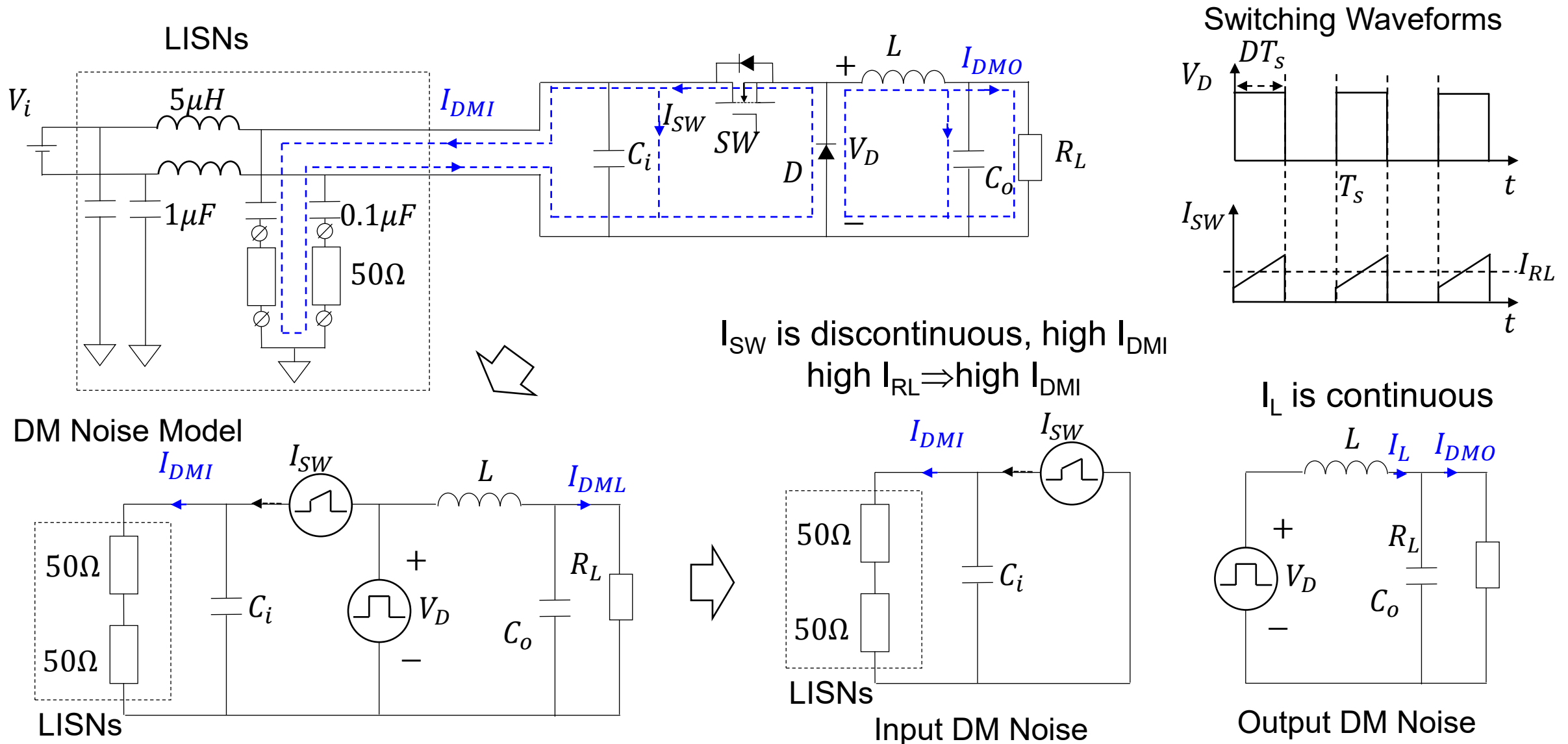


Equivalent circuit for EMI noise

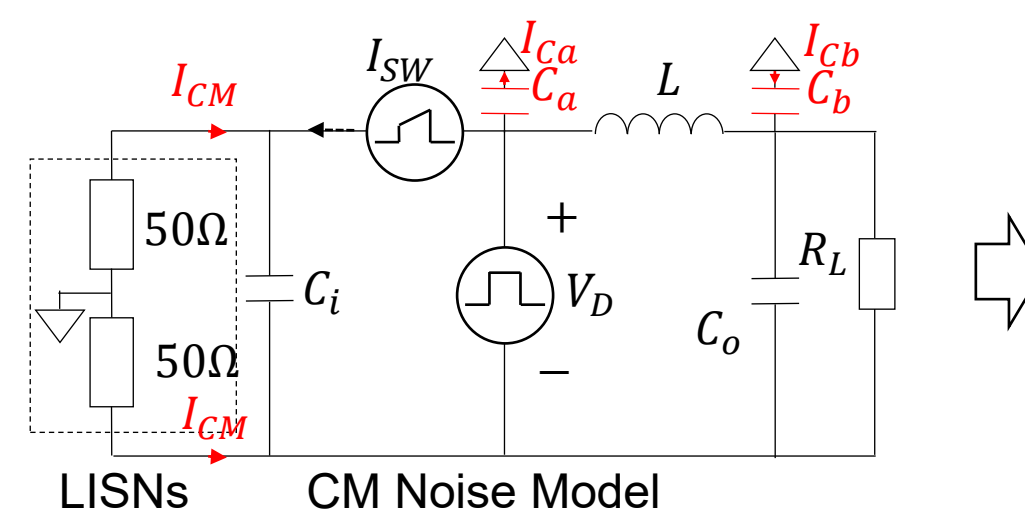
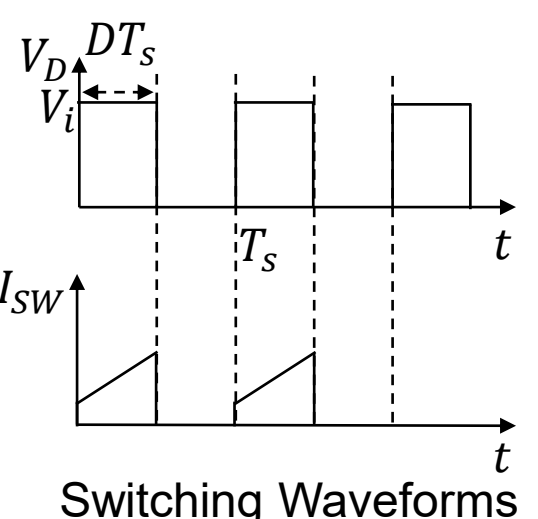
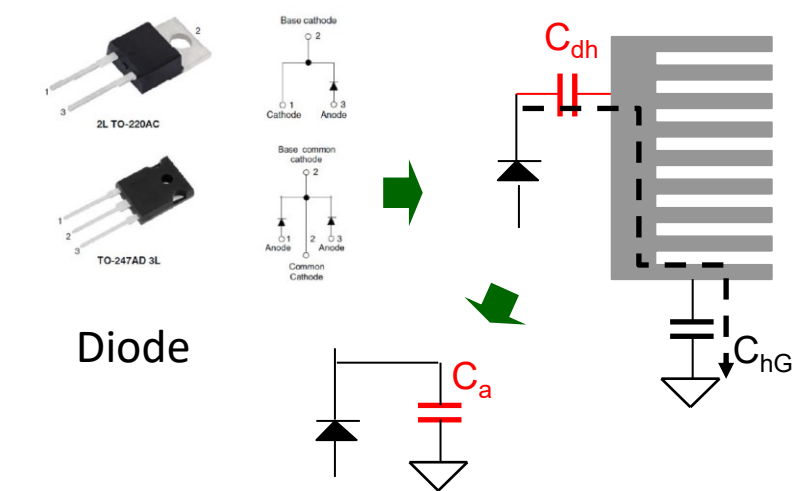
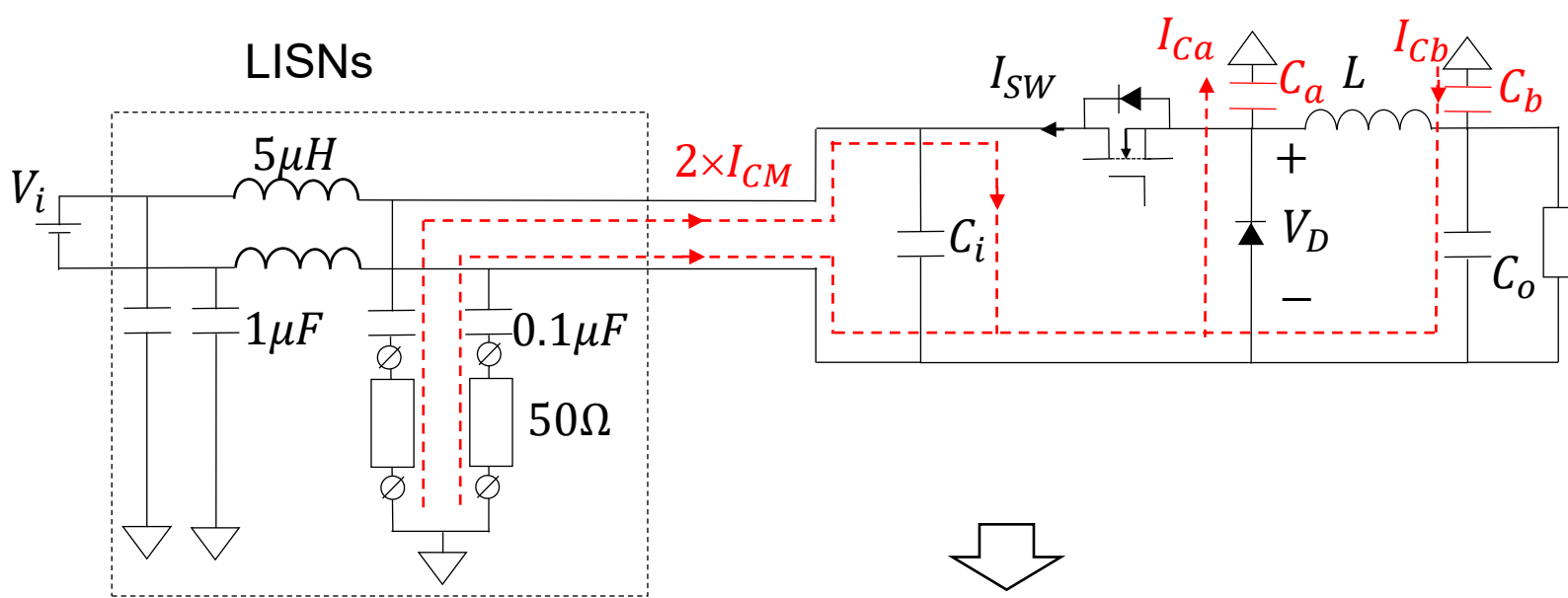


Three LISNs are needed for three phase EMI measurement (may have different parameters)

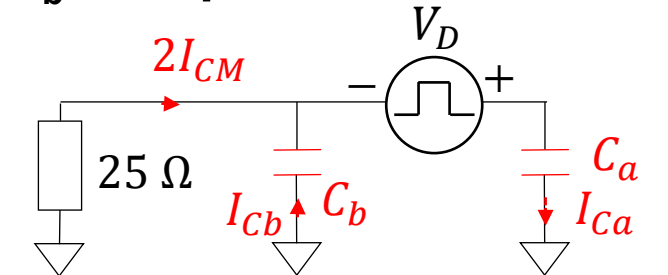
Understand the DM Conducted EMI Noise (A Buck Converter Example)



Understand the CM Conductive EMI Noise



Higher V_i , higher $f_s \rightarrow$ higher I_{CM}
 C_b is in parallel with LISNs!

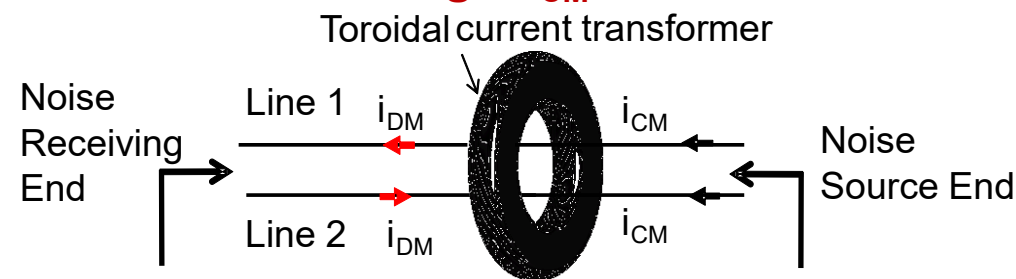


Input and output CM noise

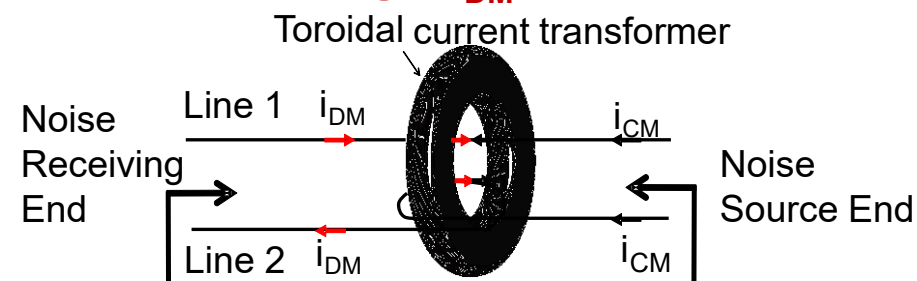
Measurement and Separation of CM and DM Noise

Method 1: using a current transformer:

CM Current Sensing: $2i_{CM}$

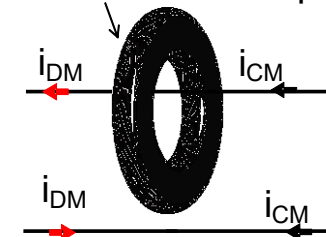


DM Current Sensing: $2i_{DM}$



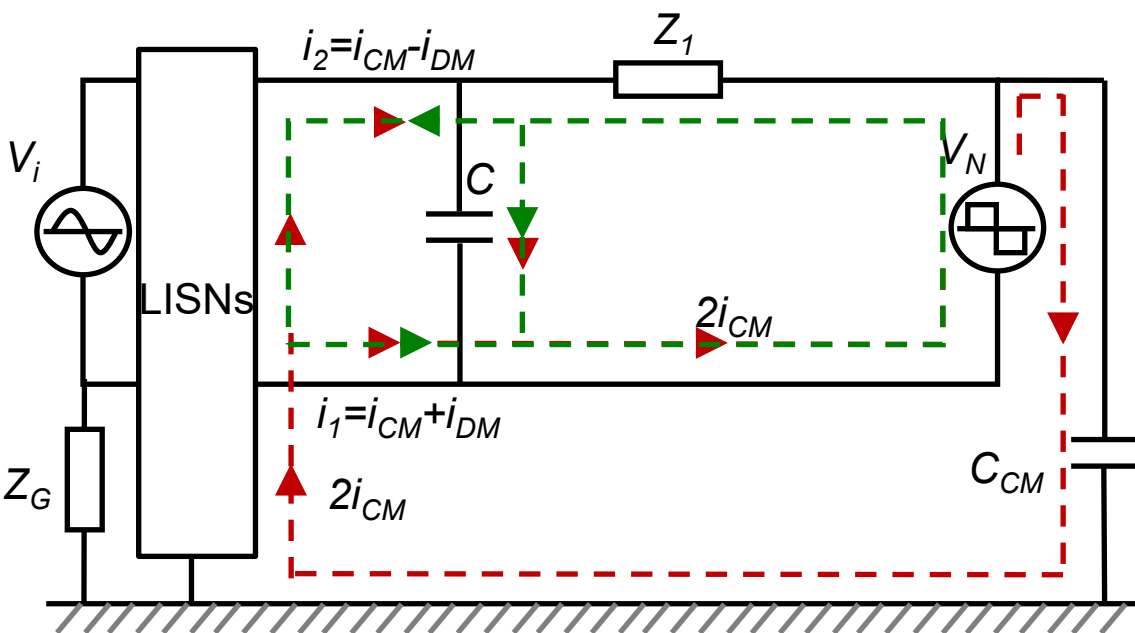
Total Current: $i_{DM} \pm i_{CM}$

Wide band current probe

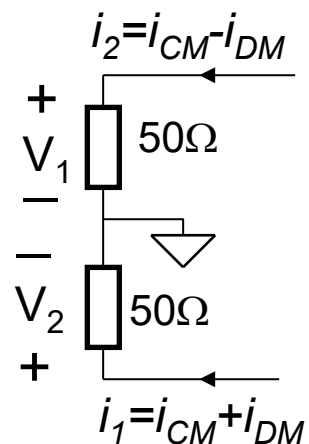


$$i_{CM} = \frac{i_1 + i_2}{2}$$

$$i_{DM} = \frac{i_1 - i_2}{2}$$

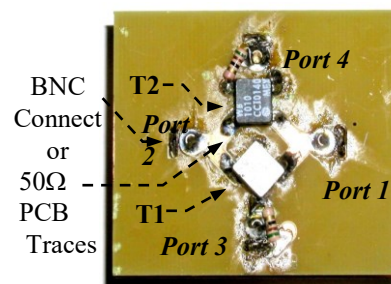


Method 2: using a noise separator



$$V_{CM} = \frac{V_1 + V_2}{2}$$

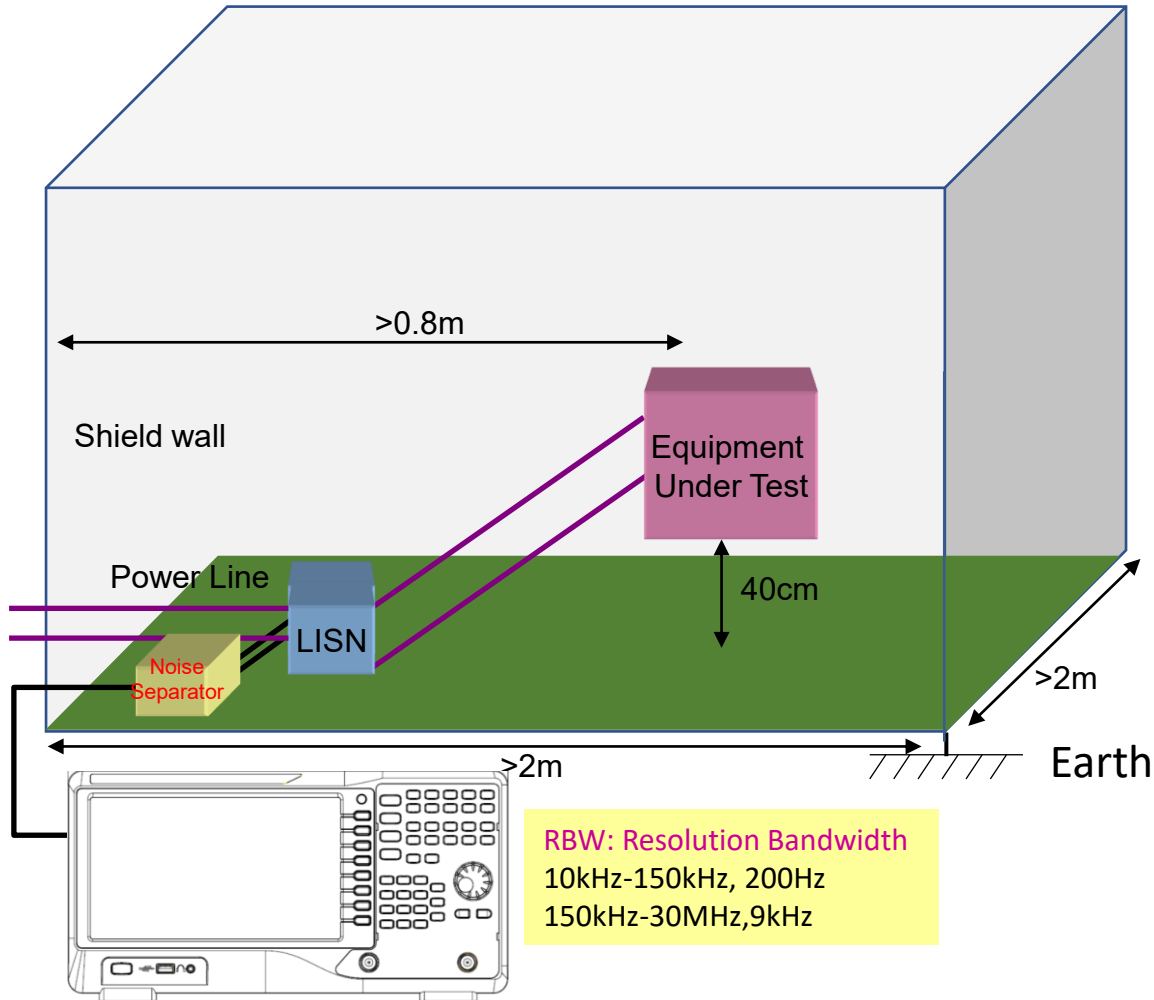
$$V_{DM} = \frac{V_1 - V_2}{2}$$



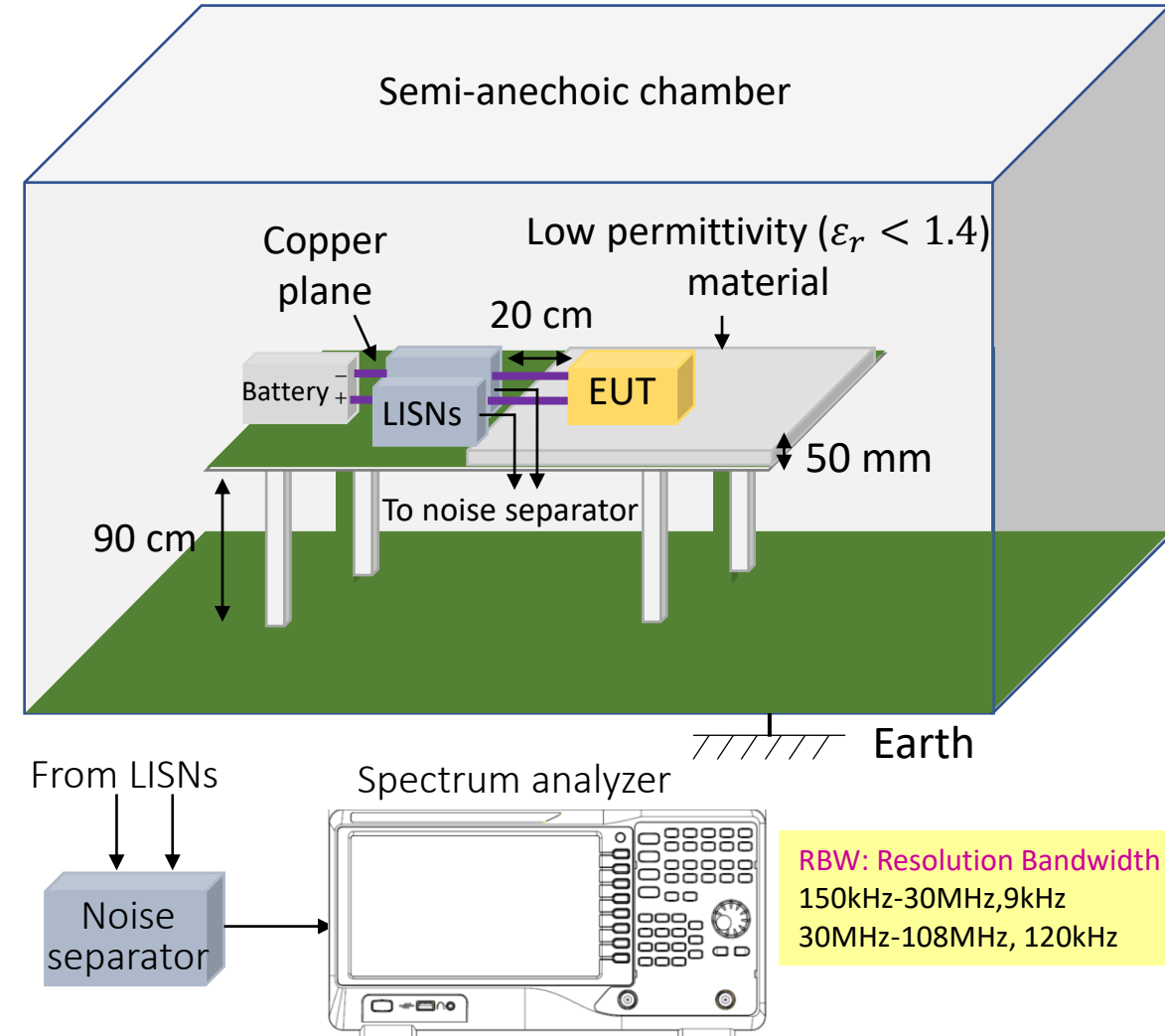
Use a noise separator

Reference: Shuo Wang, F. C. Lee and W. G. Odendaal, "Characterization, evaluation, and design of noise Separator for conducted EMI noise diagnosis," in *IEEE Transactions on Power Electronics*, vol. 20, no. 4, pp. 974-982, July 2005

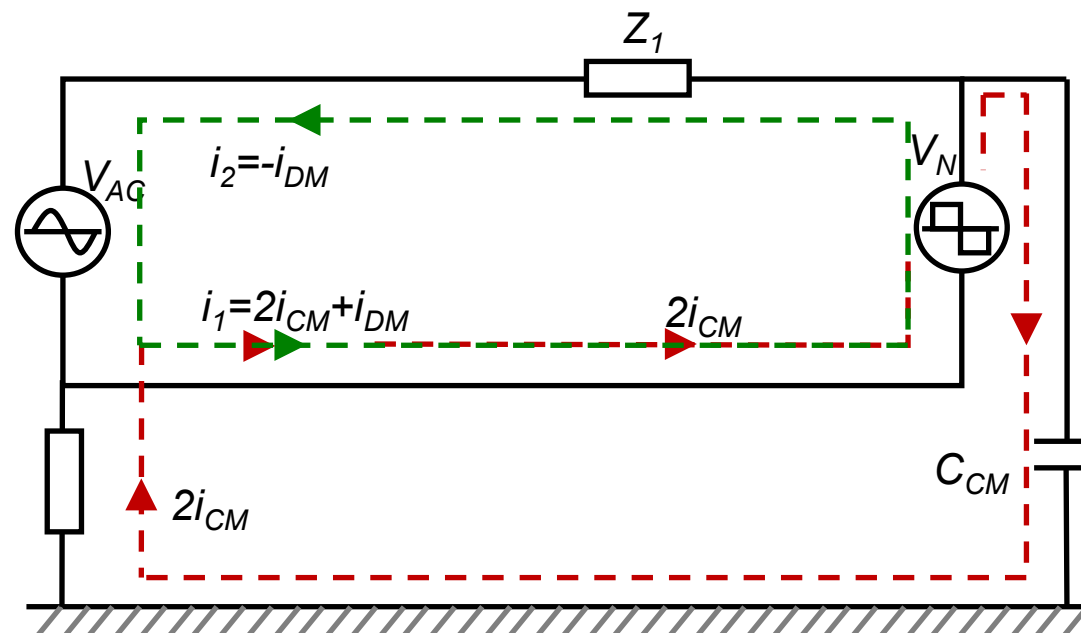
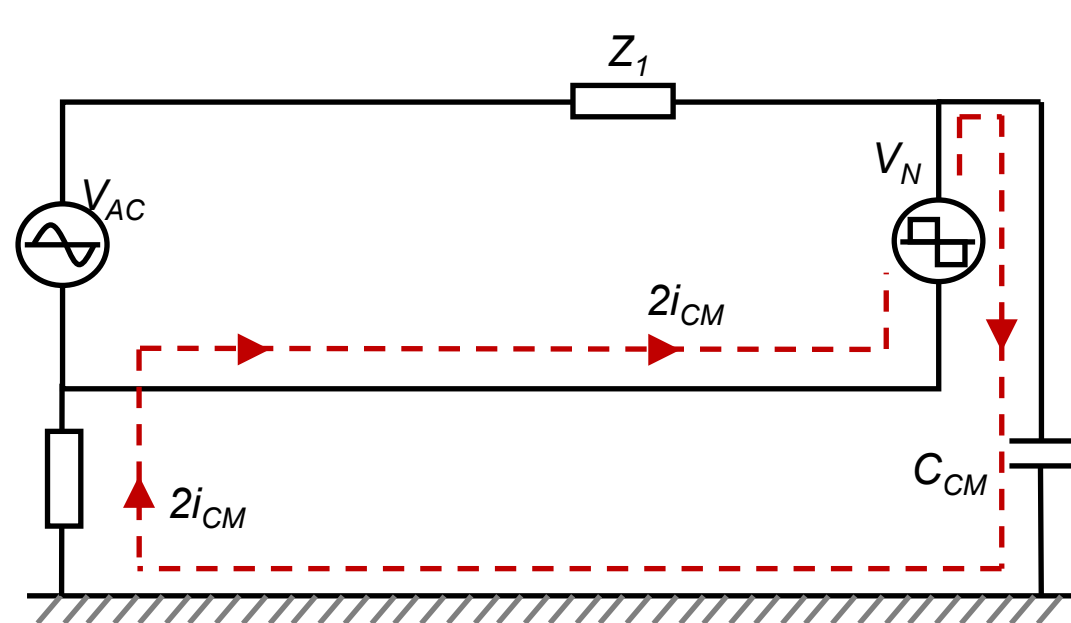
FCC test setup (10kHz-30MHz)



CISPR 25 setup (150kHz-108MHz)



Mixed Mode (MM) Currents



Mixed mode (MM) current:

$2i_{CM}$ flows through one power delivery path only

$$\frac{i_1 + i_2}{2} = i_{CM}$$

$$\frac{i_1 - i_2}{2} = i_{DM} + i_{CM} \neq i_{DM}$$

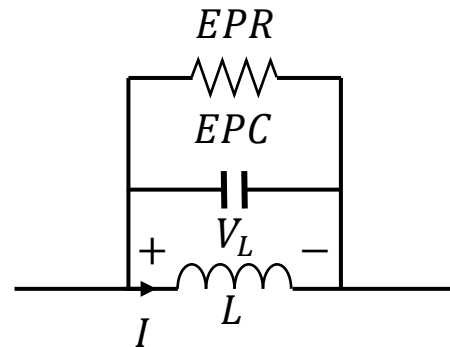
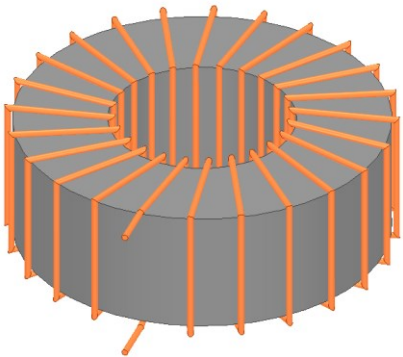
Mixed mode EMI can be avoided by balancing two lines using DM capacitors.

2.2 Power Inductors and Conductive Emissions

1. Inductance L represents the magnetic energy of the inductor
2. Winding capacitance EPC represents the electric energy of the inductor
3. Resistance EPR represents the power loss of the inductor

Under investigation:

A single layer toroidal inductor



Winding resistance is ignored here

Magnetic energy E_H determines inductance:

$$E_H = \frac{L}{4} |I|^2 \approx \int_{V_{Core}} \frac{\mu'}{4} |H|^2 dv \quad \rightarrow \quad L = \frac{4E_H}{|I|^2}$$

Electric energy E_E determines capacitance:

$$E_E = \frac{EPC}{4} |V_L|^2 \quad \rightarrow \quad EPC = \frac{4E_E}{V_L^2}$$

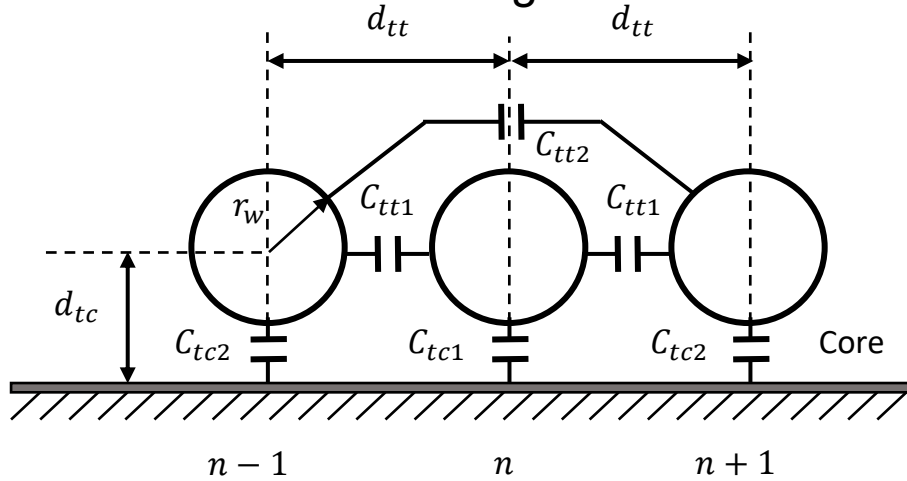
Power loss P determines resistance:

$$P = \frac{|V_L|^2}{2EPR} \quad \rightarrow \quad EPR = \frac{V_L^2}{2P}$$

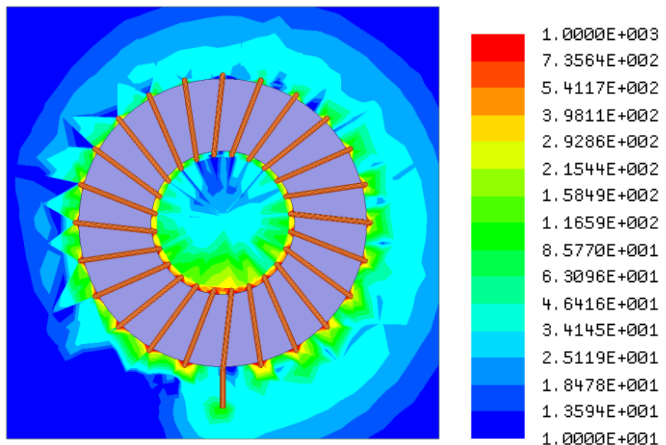
(Amplitudes are used for I , V_L and H)

Electric field distribution outside the core

Capacitance due to the voltage difference of winding turns and cores



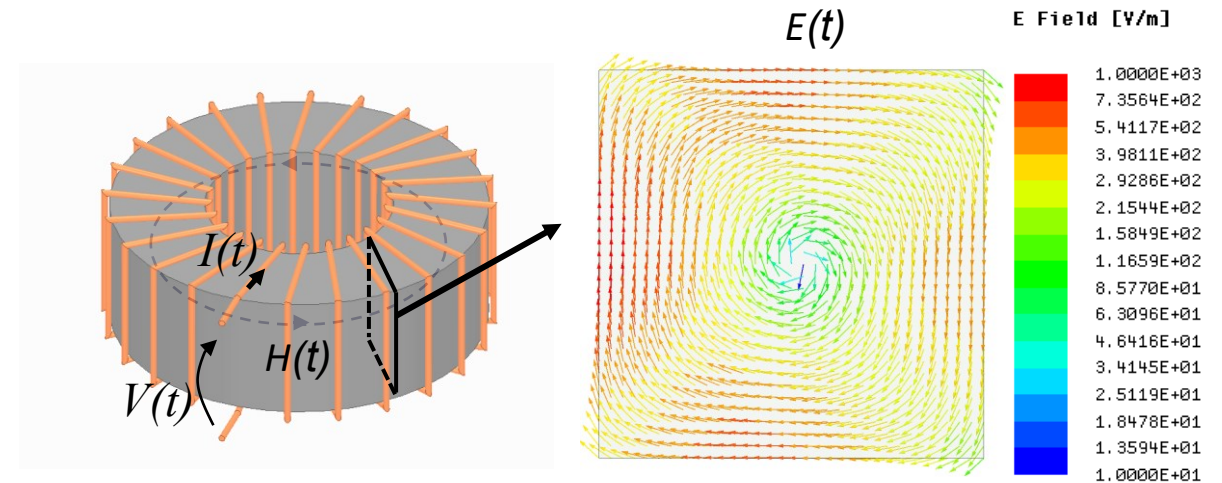
E Field [V/m]



Electric field distribution

Electric field distribution inside the core

Time varying magnetic field induces time varying electric field inside the core



Total electric field energy E_E and EPC:

$$E_E = \frac{EPC}{4} |V_L|^2 = \int_{V_{Space}} \frac{\epsilon_0}{4} |E|^2 dv + \int_{V_{Core}} \frac{\epsilon'}{4} |E|^2 dv$$

$$EPC = \frac{4E_E}{V_L^2}$$

Reference: Y. Li and S. Wang, "Modeling and Increasing the High-Frequency Impedance of Single-Layer Mn-Zn Ferrite Toroidal Inductors With Electromagnetic Analysis," in *IEEE Transactions on Power Electronics*, vol. 36, no. 6, pp. 6943-6953, June 2021, doi: 10.1109/TPEL.2020.3039809.

Power loss of cores:

1. Eddy current power loss P_E
2. Hysteresis power loss P_H
3. Dielectric power loss P_D

Core parameters:

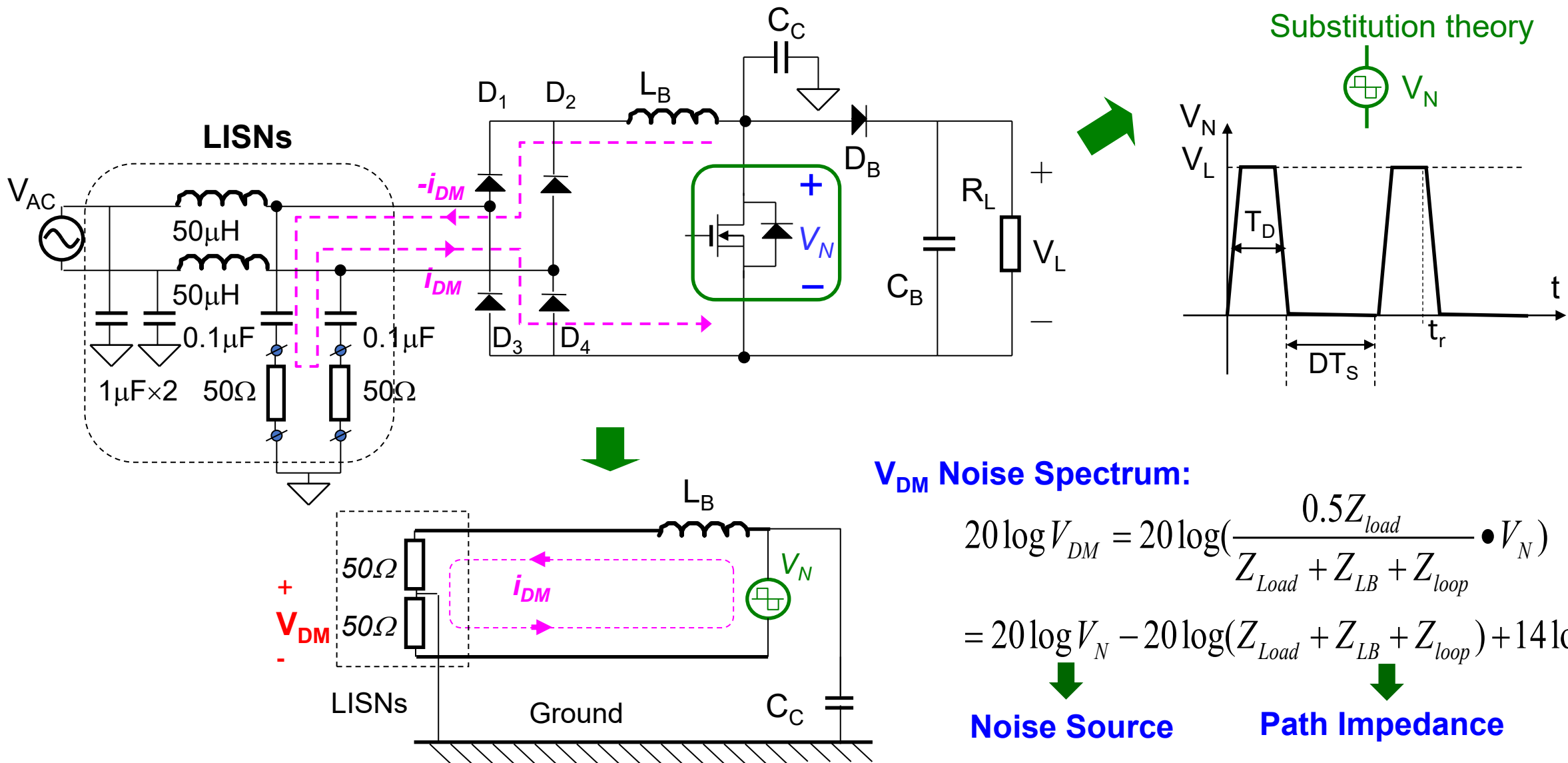
1. Conductivity: σ
2. Permeability: $\mu = \mu' - j\mu''$
3. Permittivity: $\varepsilon = \varepsilon' - j\varepsilon''$

$$\begin{aligned}
 P &= \frac{|V_L|^2}{2EPR} = P_E + P_H + P_D \\
 &= \int_{V_{Core}} \frac{1}{2} \sigma |E|^2 dv + \int_{V_{Core}} \frac{1}{2} \omega \mu'' |H|^2 dv + \int_{V_{Core}} \frac{1}{2} \omega \varepsilon'' |E|^2 dv
 \end{aligned}$$



$$EPR = \frac{|V_L|^2}{2P}$$

1. Electric field impacts both eddy current power loss and dielectric power loss, therefore EPR
2. Electric field also impacts winding capacitance EPC
3. Electric field therefore plays an important role on inductor's performance



Noise Source and Impedance Determine DM EMI Spectrum

V_{DM} Noise Spectrum:

$$20 \log V_{DM} = 20 \log \left(\frac{0.5 Z_{load}}{Z_{Load} + Z_{LB} + Z_{loop}} \bullet V_N \right)$$

$$= 20 \log V_N - 20 \log (Z_{Load} + Z_{LB} + Z_{loop}) + 14 \log Z_{Load}$$

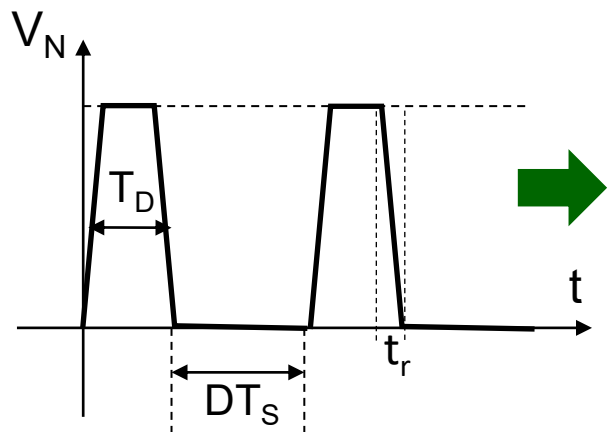


Noise Source

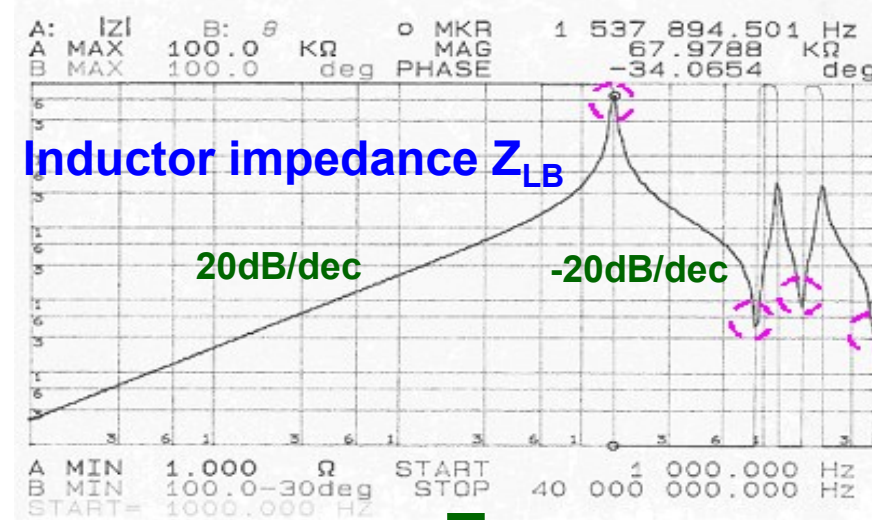
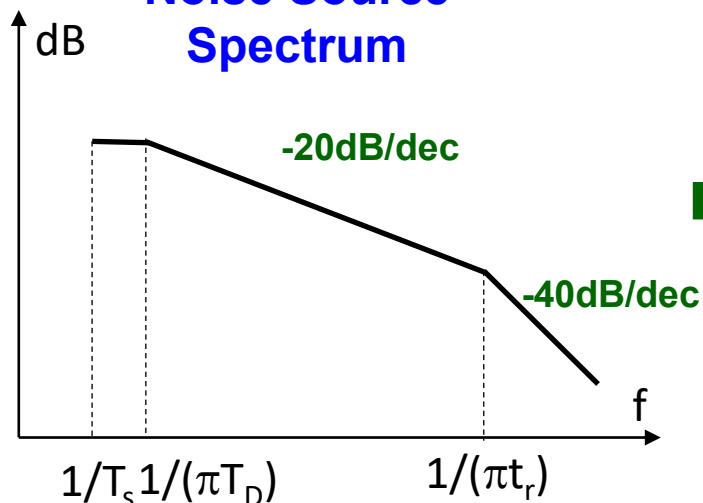


Path Impedance

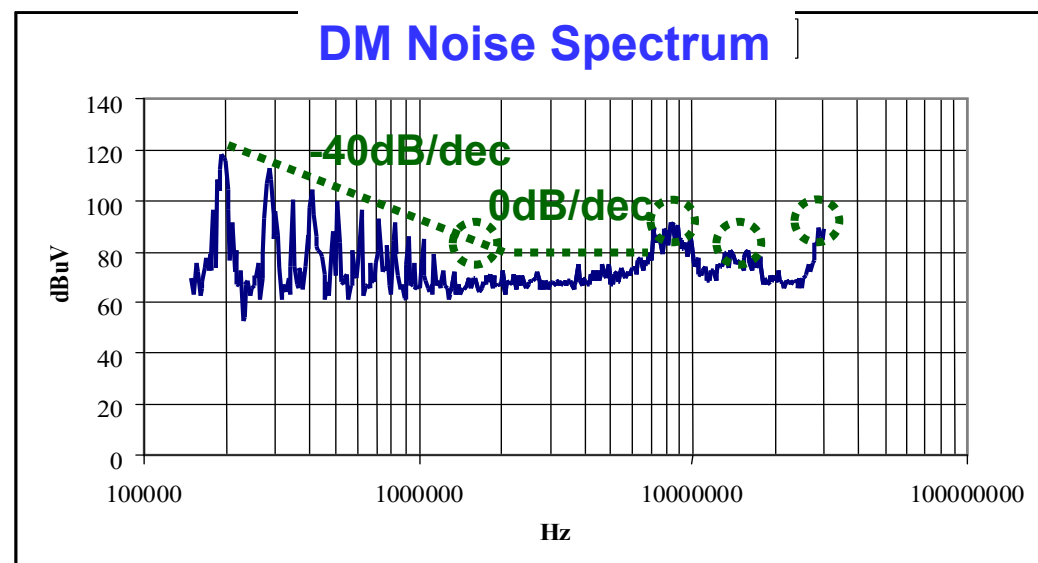
Noise Source Waveform



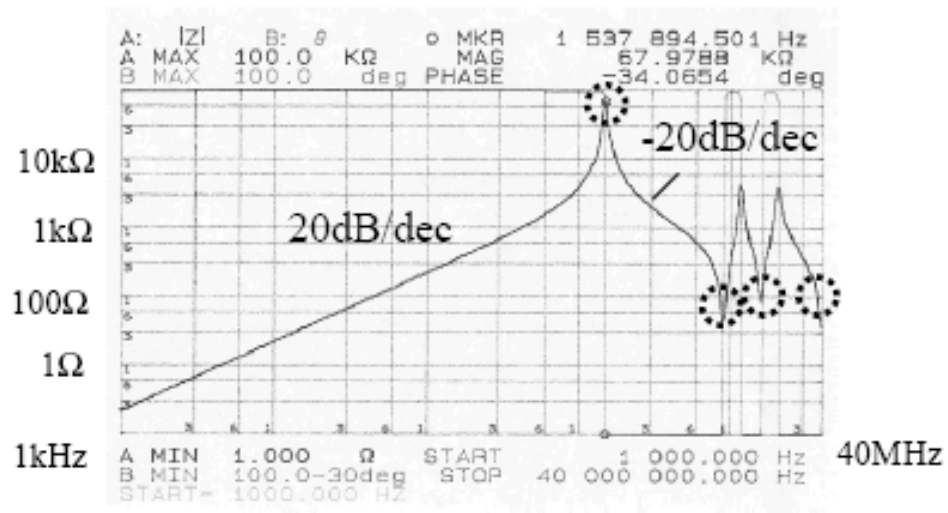
Noise Source Spectrum



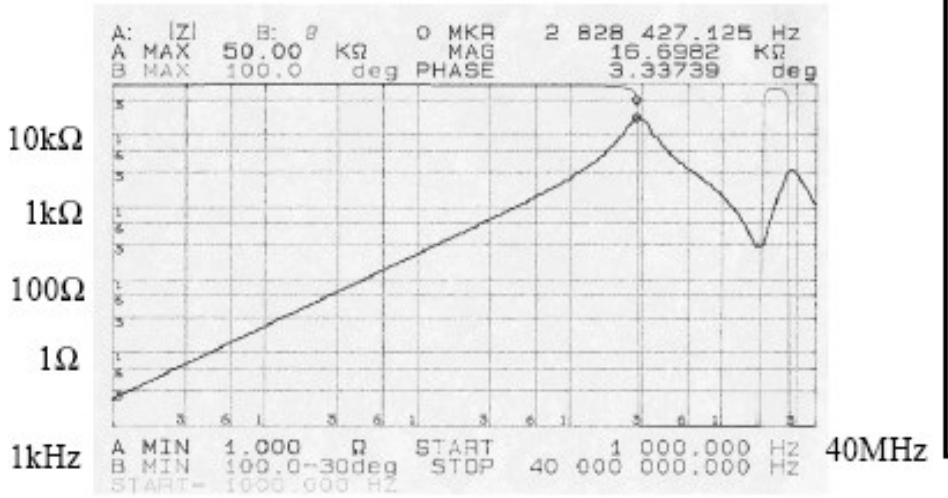
DM Noise Spectrum



DM EMI Reduction with Optimal Inductor Design



Original (Cool Mu core)



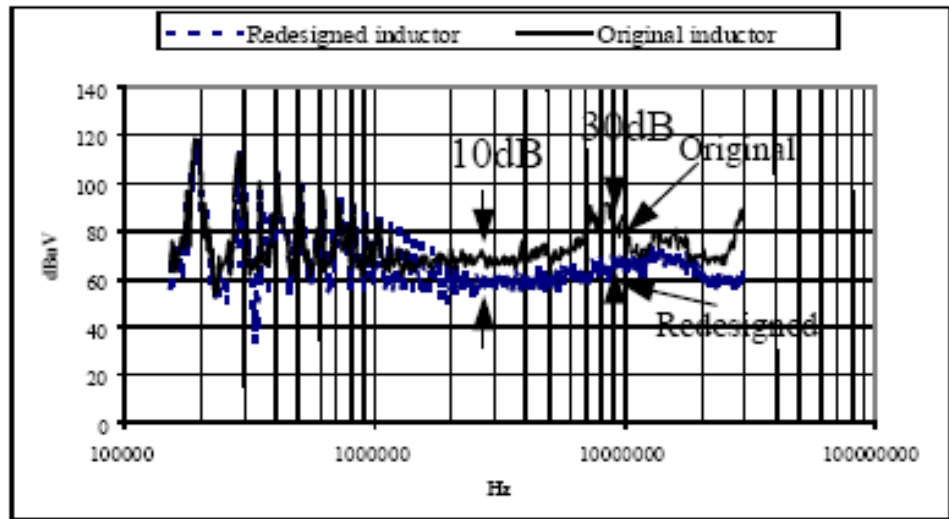
Redesigned (Iron Powder core)

Core materials:

Original: Cool Mu; $\mu_r=60$

Redesigned: Iron Powder; $\mu_r=100$

- (1) Higher HF core loss (0.46W higher);
----Higher damping at resonant frequencies
- (2) Higher permeability therefore fewer number of turns and smaller parasitic capacitances
----Higher first peak frequency. Extending self-attenuation to higher frequency.

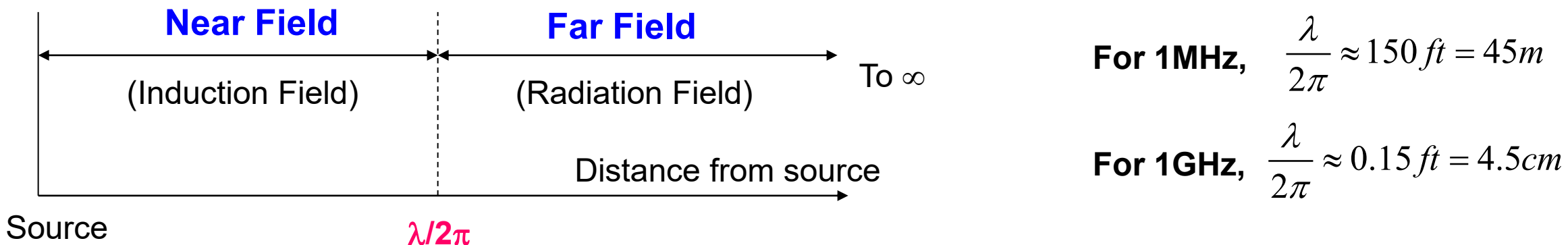


- HF lossy inductor is good for HF EMI reduction
- Always sweep inductor impedance

Reference: Shuo Wang, F. C. Lee and W. G. Odendaal, "Single layer iron powder core inductor model and its effect on boost PFC EMI noise," *IEEE 34th Annual Conference on Power Electronics Specialist, 2003. PESC '03.*, 2003, pp. 847-852 vol.2, doi: 10.1109/PESC.2003.1218167.

3.1 Near Field Emission in Power Electronics Systems

Near Field and Far Field



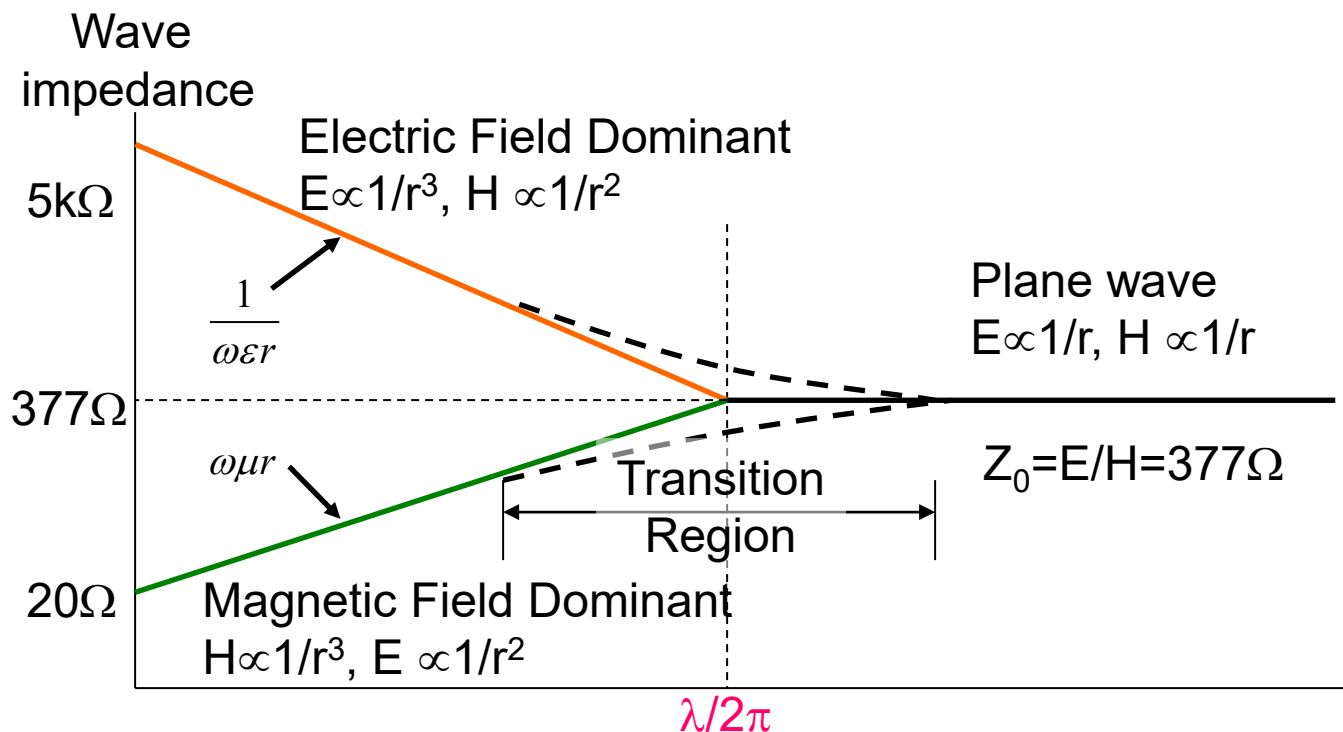
Wave Impedance:

$$Z = \frac{E}{H} = \sqrt{\frac{j\omega\mu}{\sigma + j\omega\epsilon}}$$

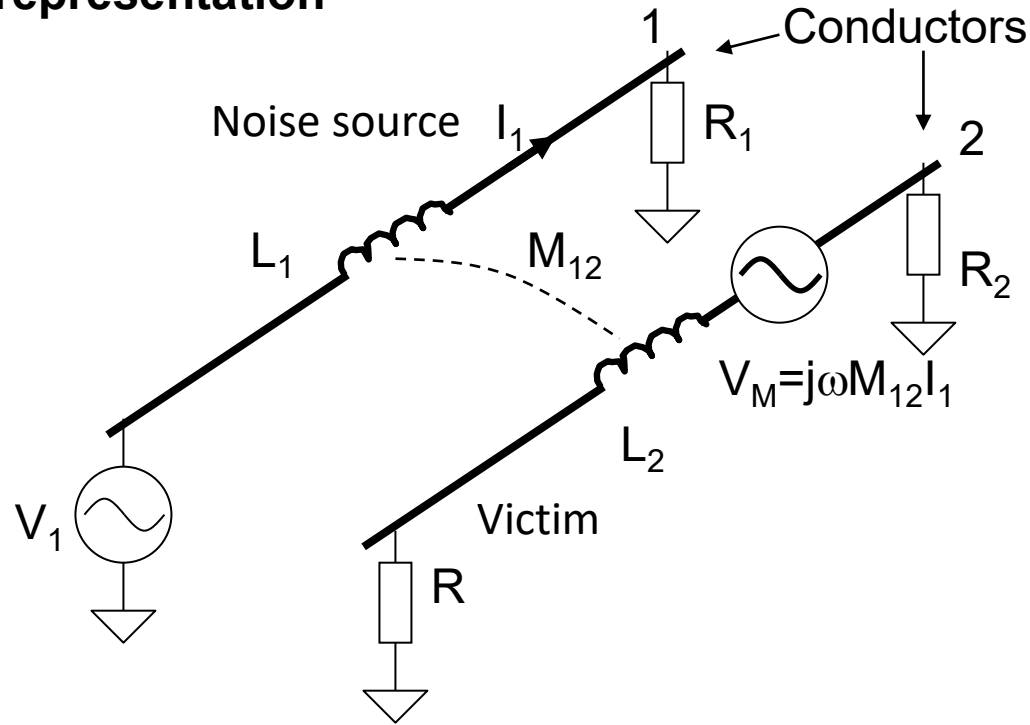
$$Z_{Air} = \sqrt{\frac{\mu_0}{\epsilon_0}} = 377\Omega$$

High voltage
& low current
source

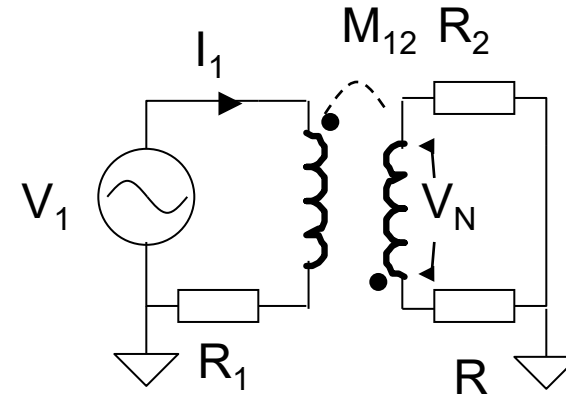
High current
& low voltage
source



Physical representation



Equivalent circuit



V_N is the noise voltage on two resistors

$$V_N \approx \frac{j\omega M_{12} I_1}{1 + \frac{j\omega L_2}{R + R_2}}$$

At low frequencies:

$$V_N = V_M = j\omega M_{12} I_1$$

Not a function of load: voltage source

At high frequencies:

$$V_N = \frac{M_{12}}{L_2} I_1 (R + R_2)$$

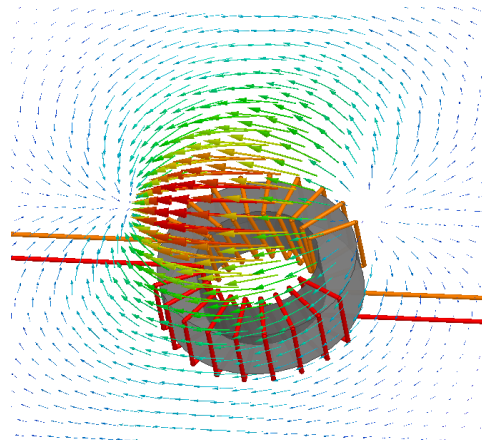
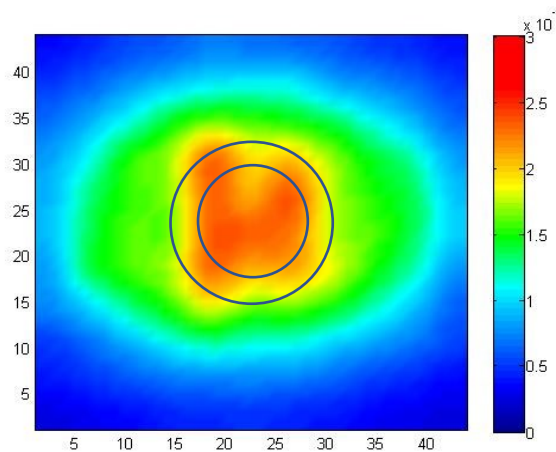
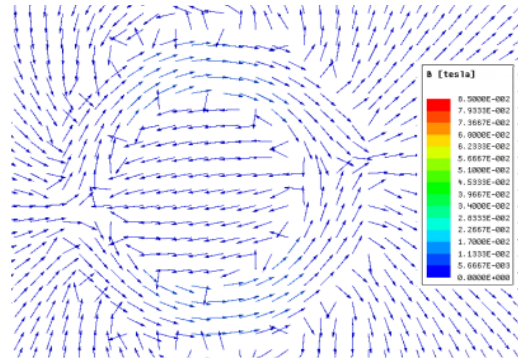
Proportional to load: current source

Near Inductive/Magnetic Field

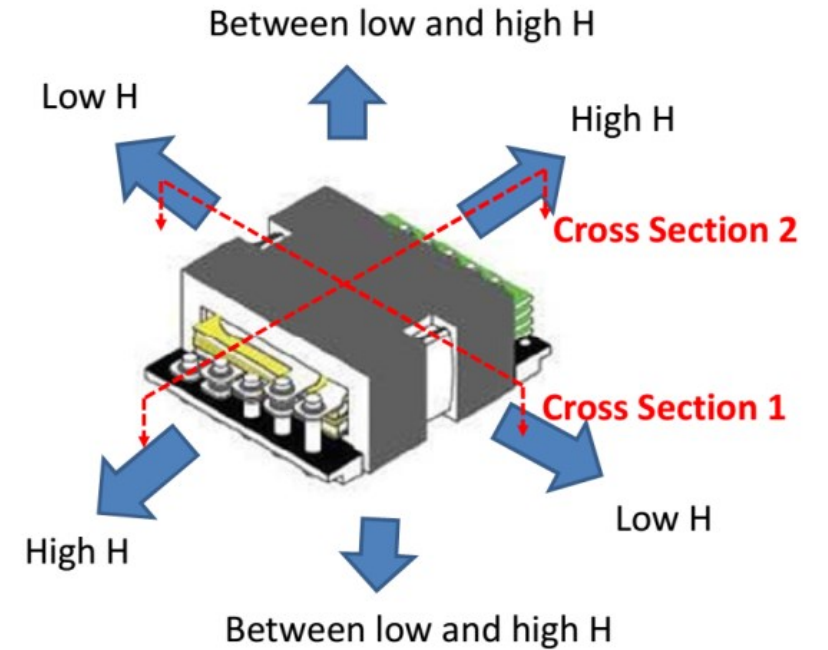
Near magnetic field sources:

Inductors, transformers, high di/dt current loops, HF noise current loops, etc.

CM Inductor w/ DM current excitation

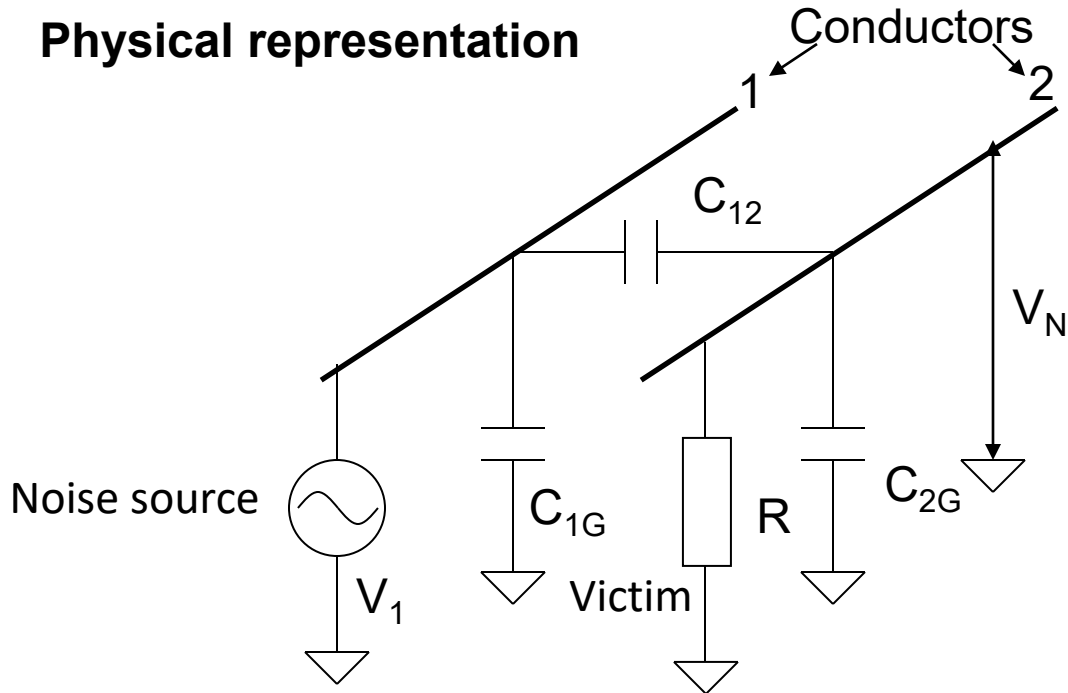


Transformers

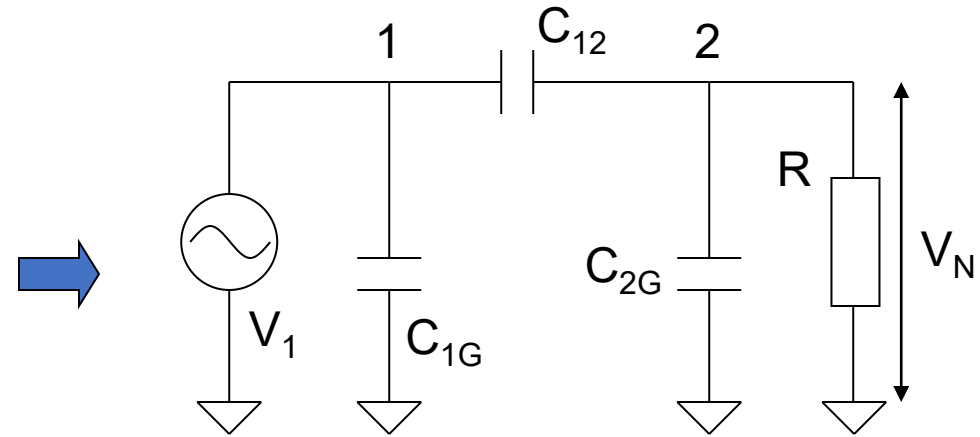


Near Capacitive/Electric Field Coupling Modeling

Physical representation



Equivalent circuit



$$V_N = \frac{j\omega[C_{12} / (C_{12} + C_{2G})]}{j\omega + 1/R(C_{12} + C_{2G})} V_1$$

At low frequencies:

$$\text{If, } R \ll \frac{1}{\omega(C_{12} + C_{2G})},$$

$$V_N = j\omega RC_{12} V_1$$

Proportional to load: current source

At high frequencies:

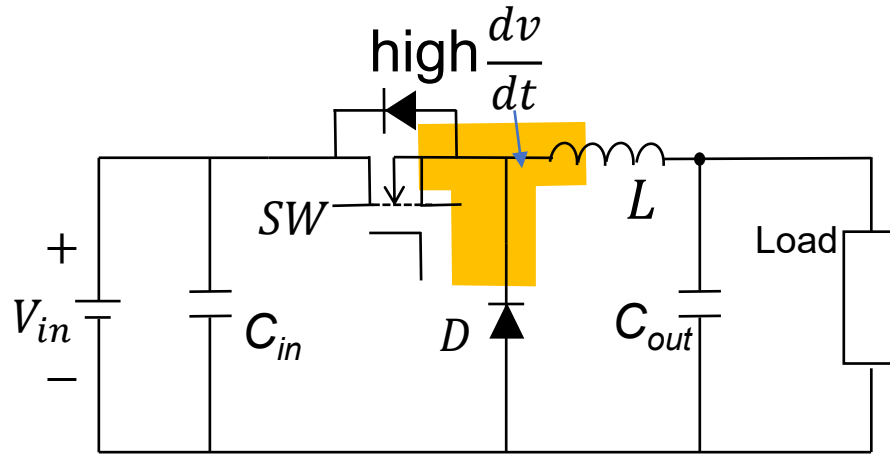
$$\text{If } R \gg \frac{1}{\omega(C_{12} + C_{2G})},$$

$$V_N = \left(\frac{C_{12}}{C_{12} + C_{2G}}\right) V_1$$

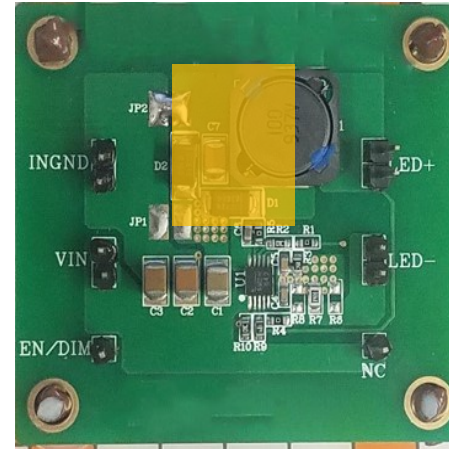
Not a function of load: voltage source

Near electric field sources:

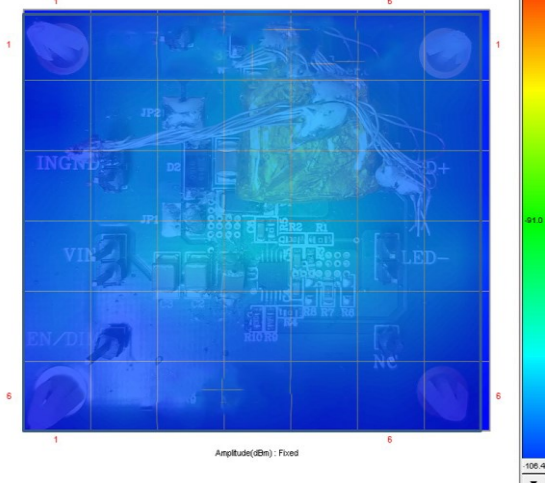
High dv/dt nodes, HF noise voltage nodes, inductors, transformers, etc.



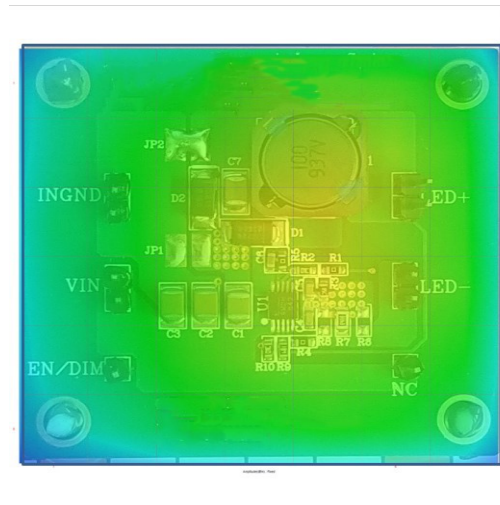
Buck converter



High dv/dt area:
PCB node of the
inductor,
MOSFET and diode

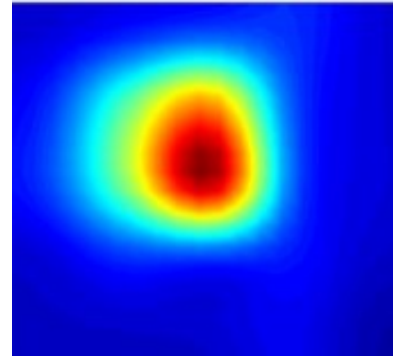
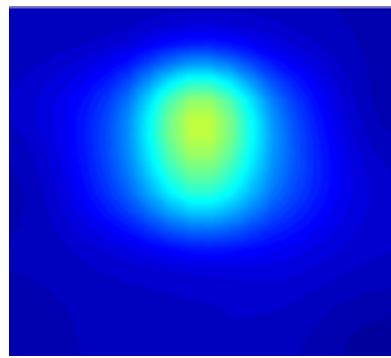
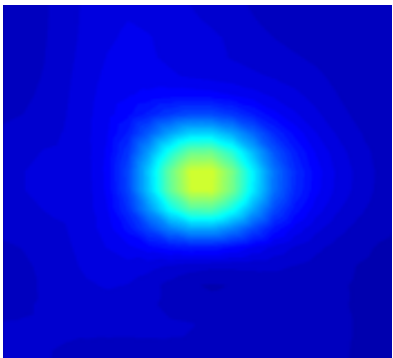
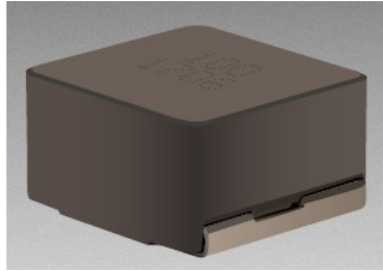


With shielding

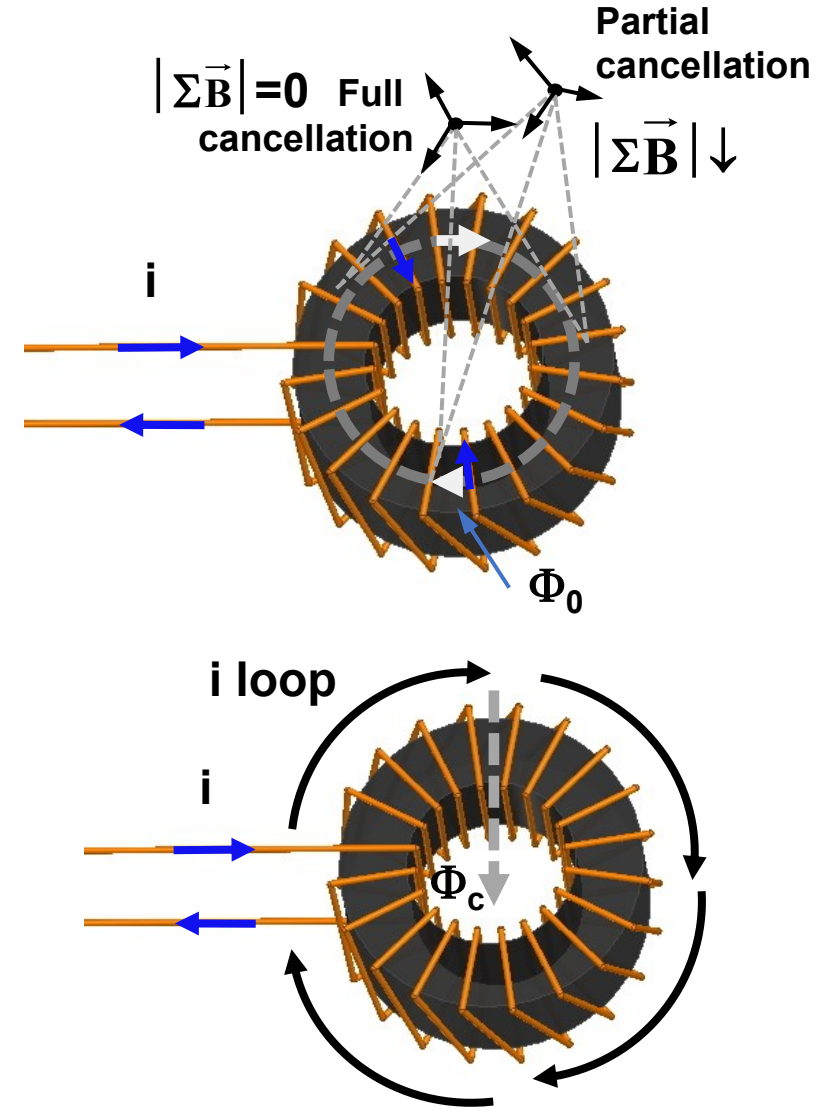


Measured E field
at switching f

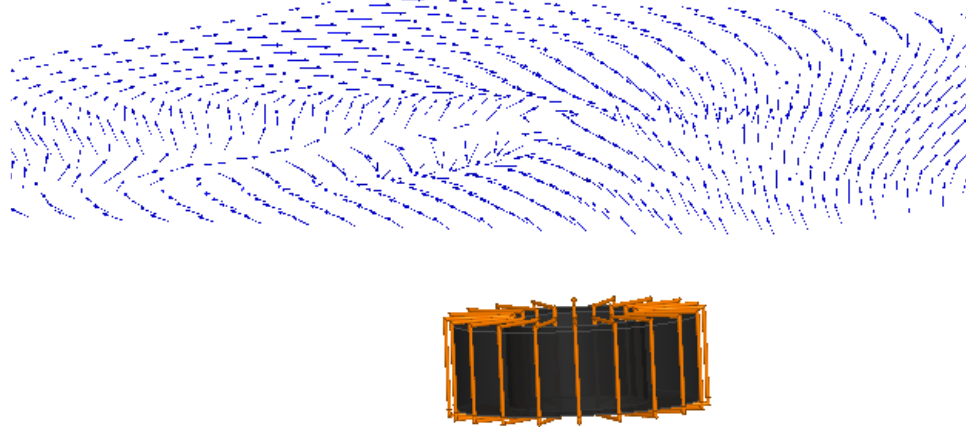
3.2 Power Inductor's Near Field Emissions



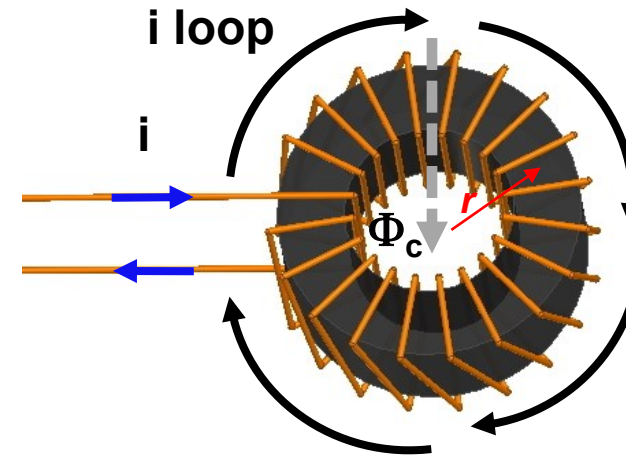
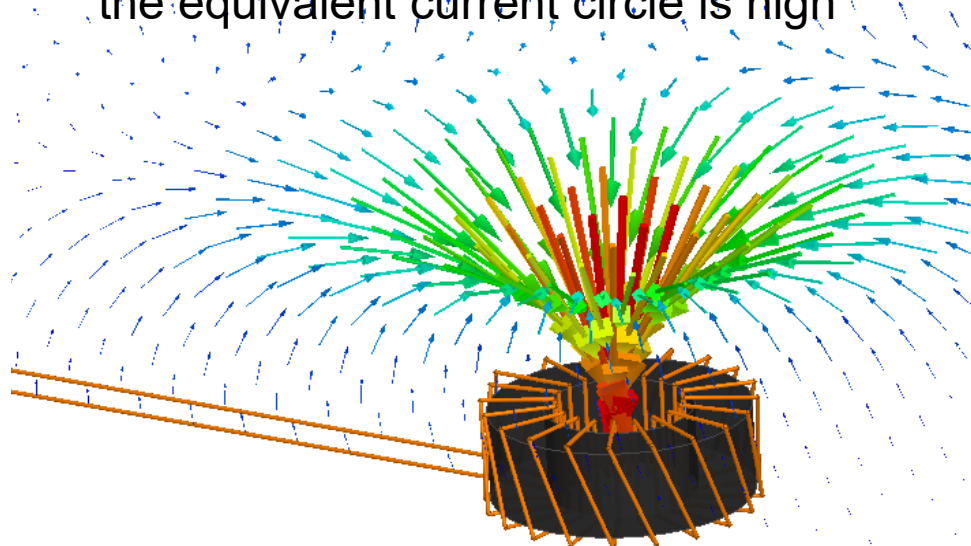
The measured near magnetic field
2cm above the inductors



The near magnetic field generated from 360° winding turns is small due to partial cancellation



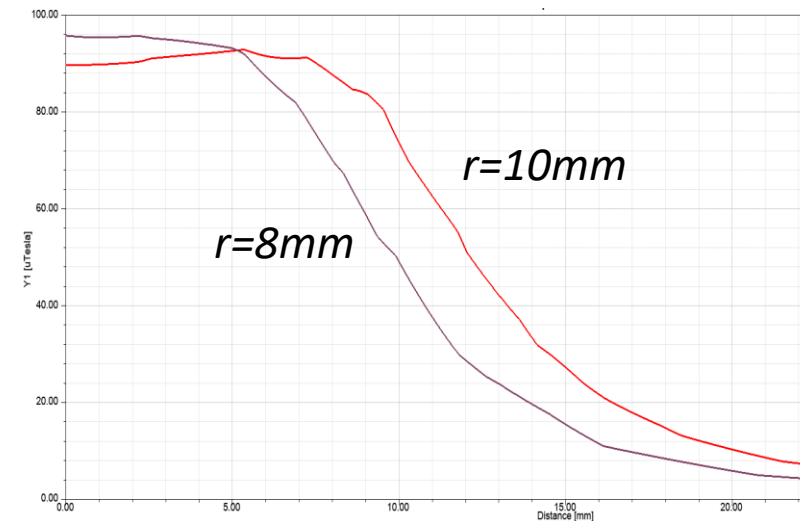
The near magnetic field generated from the equivalent current circle is high



$$\Phi_c = i(\mu_0 r \left[\ln \left(\frac{1.05r}{a} \right) \right])$$

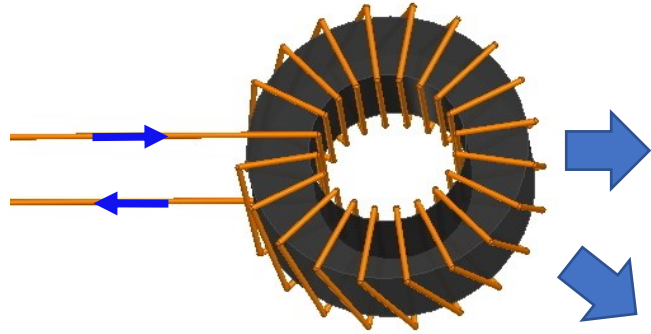
r is average radius of the core and a is wire conductor's radius

Larger r , higher magnetic field emission

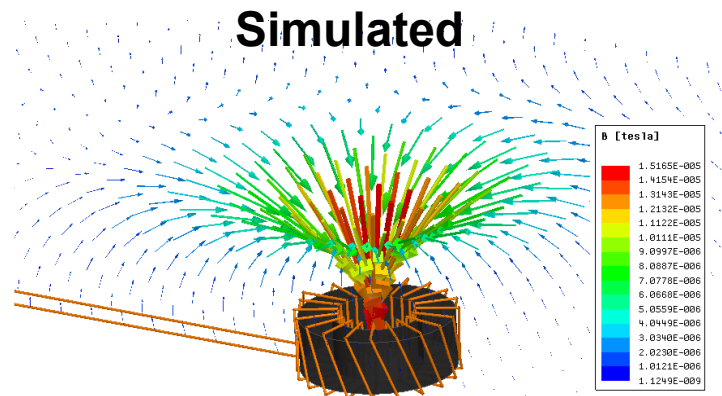


Reference: B. Zhang and S. Wang, "Analysis and Reduction of the Near Magnetic Field Emission From Toroidal Inductors," in *IEEE Transactions on Power Electronics*, vol. 35, no. 6, pp. 6251-6268, June 2020, doi: 10.1109/TPEL.2019.2953748.

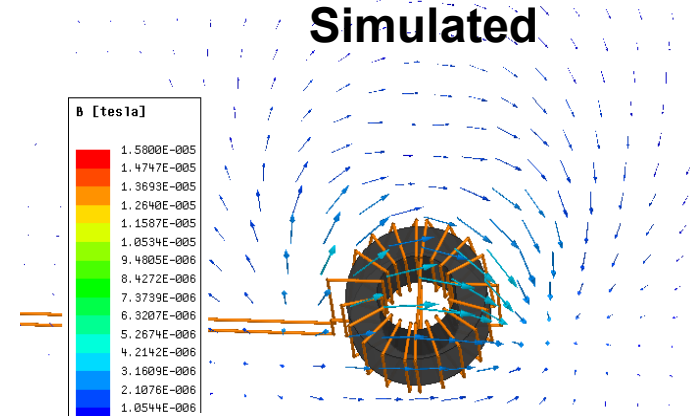
Conventional



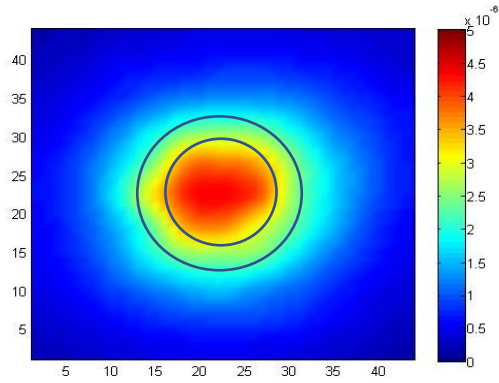
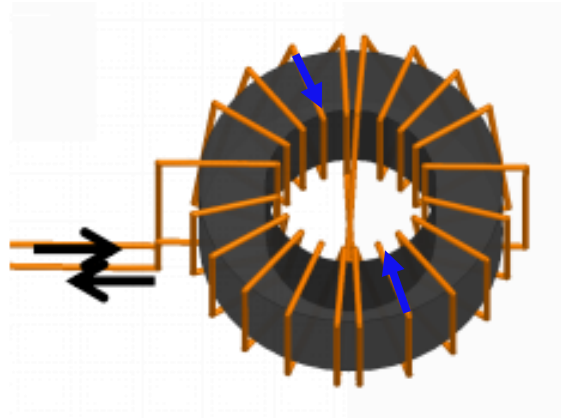
Simulated



Simulated

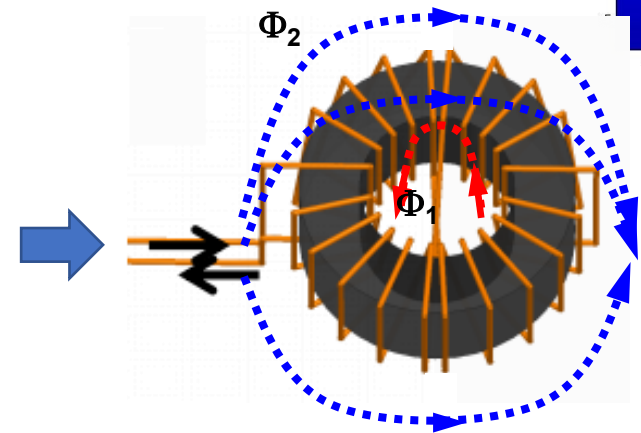
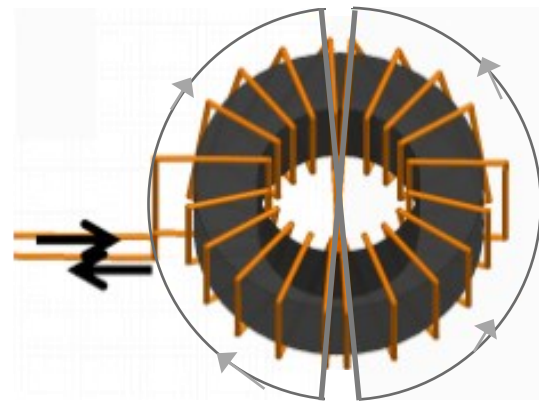
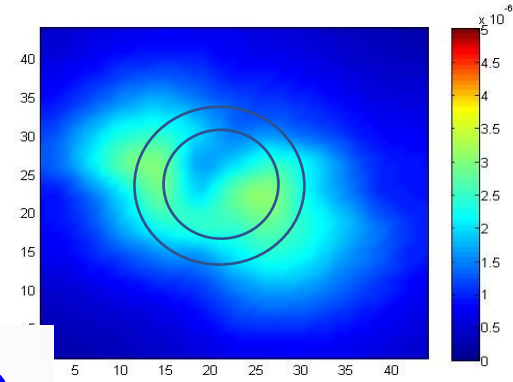


Twisted Winding



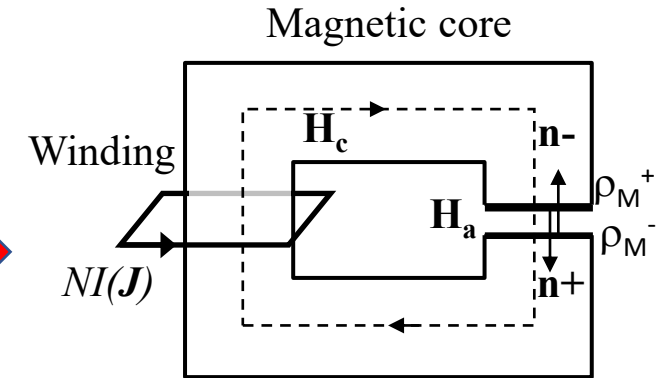
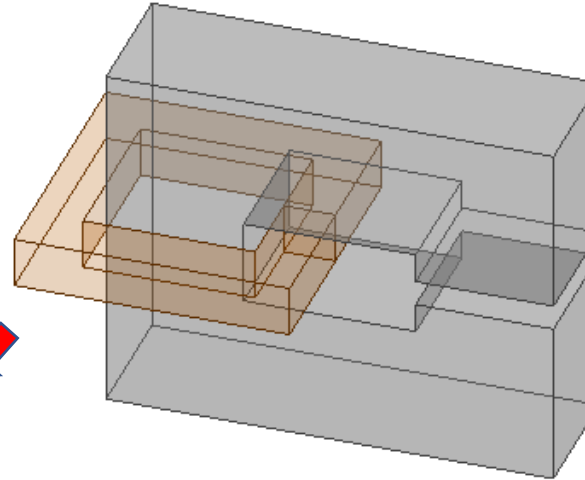
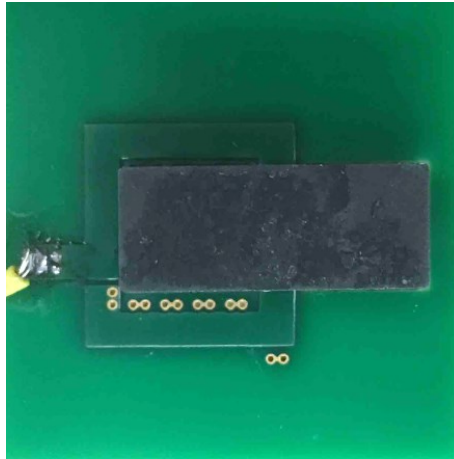
Measured

Measured

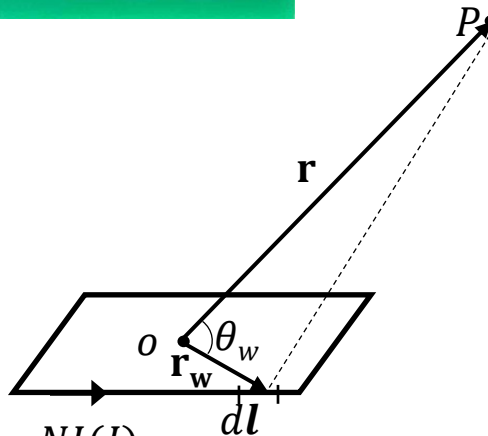


Magnetic field is partially canceled

Inductor Near Magnetic Field Emission Modeling with Magnetic Moments



$\mathbf{A}_{Jdip}(\mathbf{r})$

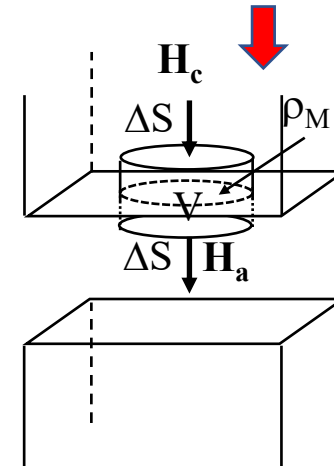


$$\mathbf{m}_J = NI \int d\mathbf{a} = NIA_w \hat{\mathbf{a}}$$

Magnetic vector potential $NI(J)$

$$\mathbf{A}_{Jdip}(\mathbf{r}) = \frac{\mu_0 NI}{4\pi r^2} \oint r_w \cos \theta_w d\mathbf{l} = \frac{\mu_0}{4\pi} \frac{\mathbf{m}_J \times \hat{\mathbf{r}}}{r^2}$$

$\nabla \times \mathbf{A}_J = \mu_0 \mathbf{H}$

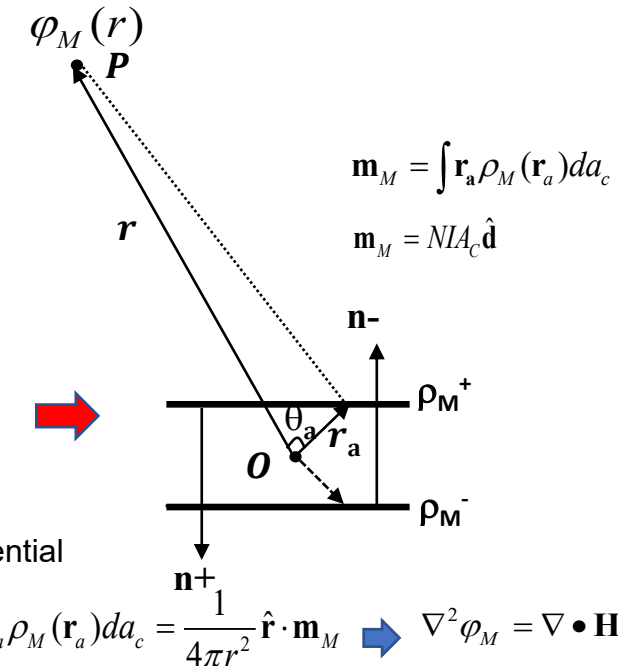


$$\rho_M = \mathbf{n} \cdot (\mathbf{H}_a - \mathbf{H}_c)$$

(Gauss law)

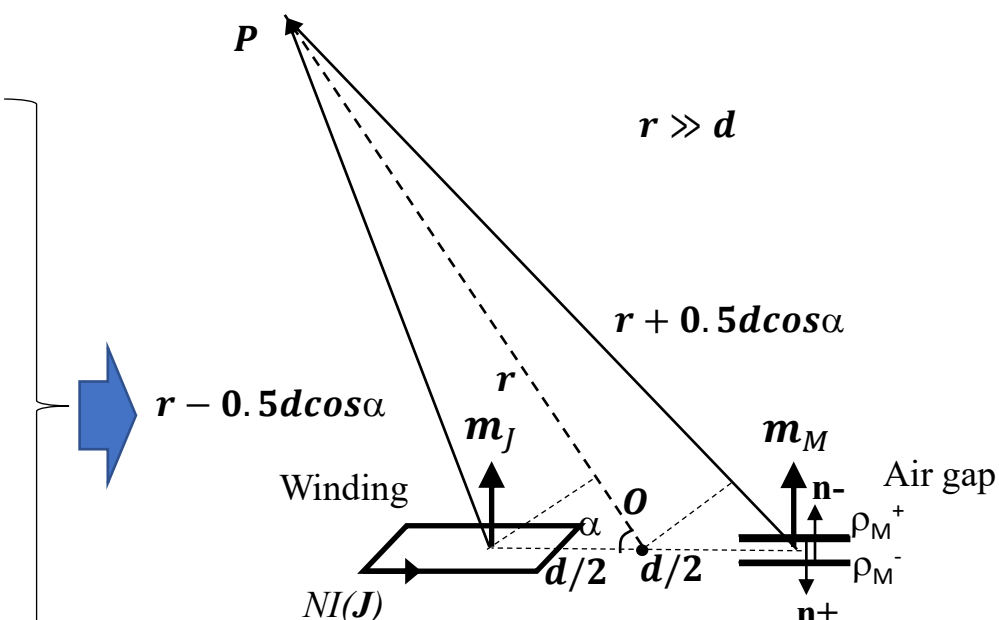
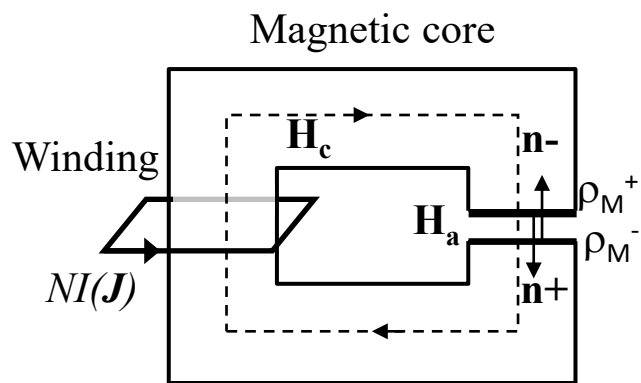
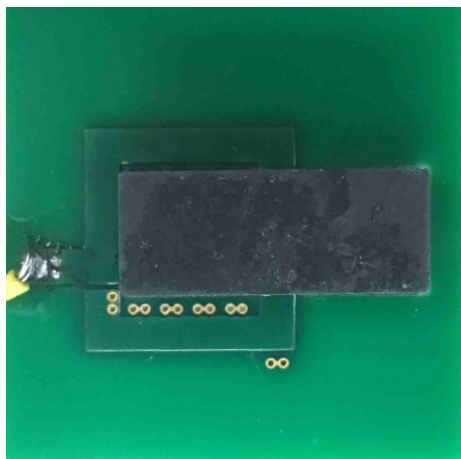
Scalar voltage potential

$$\varphi_{Mdip}(\mathbf{r}) = \frac{1}{4\pi r^2} \int r_a \cos \theta_a \rho_M(\mathbf{r}_a) da_c = \frac{1}{4\pi r^2} \hat{\mathbf{r}} \cdot \mathbf{m}_M \rightarrow \nabla^2 \varphi_M = \nabla \cdot \mathbf{H}$$



$$\mathbf{m}_M = \int \mathbf{r}_a \rho_M(\mathbf{r}_a) da_c$$

$$\mathbf{m}_M = NIA_c \hat{\mathbf{d}}$$

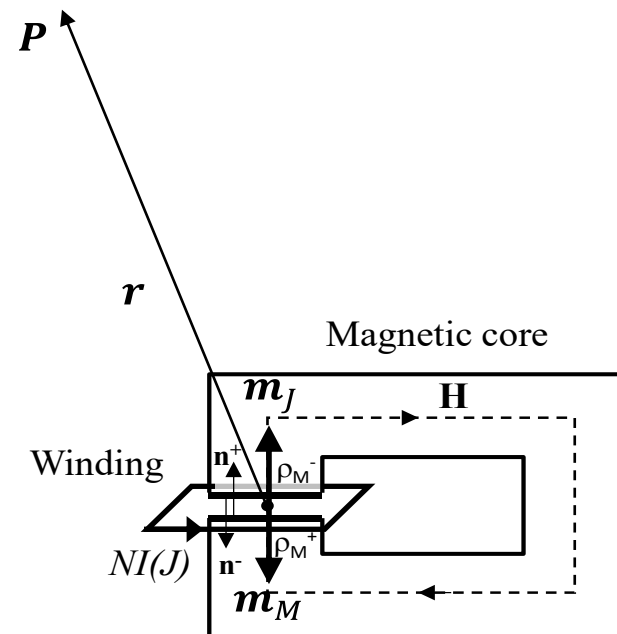


$$\mathbf{H}(r, \theta) = \mathbf{H}_{Jdip}(r, \theta) + \mathbf{H}_{Mdip}(r, \theta)$$

$$\approx \frac{NI}{4\pi} \left(2 \cos \theta \hat{\mathbf{r}} + \sin \theta \hat{\boldsymbol{\theta}} \right) \left(\frac{2A}{r^3} \right)$$

where, $A = 0.5(A_W + A_C)$

A better design for near magnetic field reduction



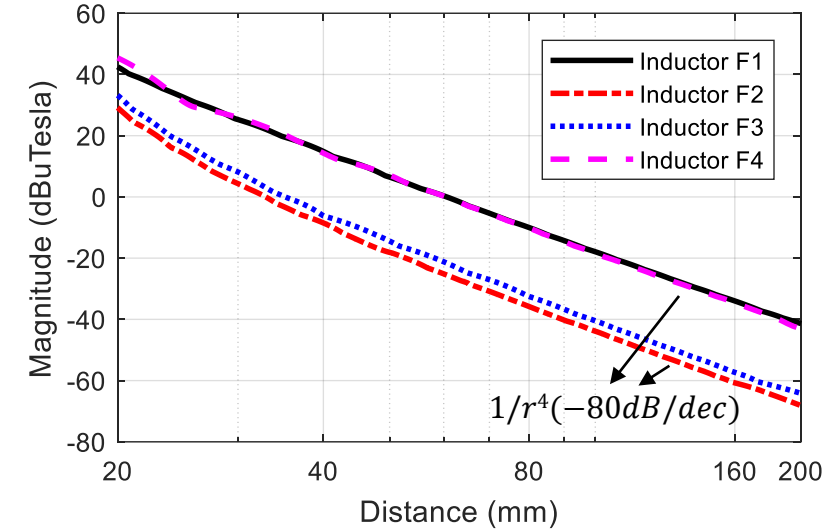
$$\mathbf{H}(r, \theta) = \mathbf{H}_{Jdip}(r, \theta) + \mathbf{H}_{Mdip}(r, \theta)$$

$$\approx \frac{NI}{4\pi} \left(2 \cos \theta \hat{\mathbf{r}} + \sin \theta \hat{\boldsymbol{\theta}} \right) \left[\frac{2\Delta A}{r^3} + \frac{3Ad \cos \alpha}{r^4} \right]$$

where, $\Delta A = 0.5(A_W - A_C)$

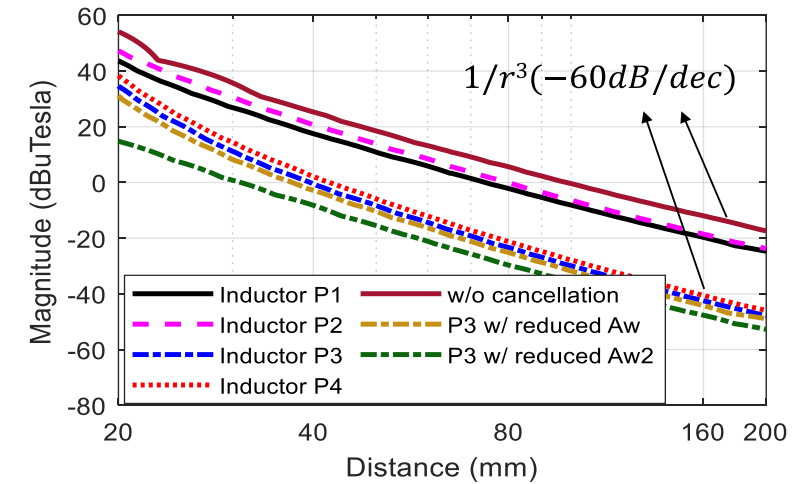
$$H \propto 1/r^4$$

No.	F1	F2	F3	F4
Inductors and dipole moments				
Parameters	$N_{1,2} = 3$ $\mu_r = 3300$ $l_{g1,2} = 0.25\text{mm}$ $L = 7.4 \mu\text{H}$	$N_{1,2} = 3$ $\mu_r = 3300$ $l_{g1,2} = 0.25\text{mm}$ $L = 6.5 \mu\text{H}$	$N_{1,2} = 3$ $\mu_r = 3300$ $l_{g1,2,3,4} = 0.125\text{mm}$ $L = 6.4 \mu\text{H}$	$N_{1,2} = 3$ $\mu_r = 3300$ $l_{g1,2,3,4} = 0.125\text{mm}$ $L = 8.5 \mu\text{H}$



$$H \propto 1/r^3$$

No.	No cancellation	P1	P2	P3	P4
Inductors and dipole moments					
Parameters	$N = 6$ $\mu_r = 3300$ $l_g = 0.5\text{mm}$ $L = 7.1\mu\text{H}$	$N = 6$ $\mu_r = 3300$ $l_{g1,2} = 0.25\text{mm}$ $L = 7.3\mu\text{H}$	$N = 6$ $\mu_r = 95$ <i>distributed airgaps</i> $L = 7.0\mu\text{H}$	$N = 6$ $\mu_r = 3300$ $l_g = 0.5\text{mm}$ $L = 7.1\mu\text{H}$	$N = 6$ $\mu_r = 3300$ $l_{g1,2} = 0.25\text{mm}$ $L = 6.9\mu\text{H}$

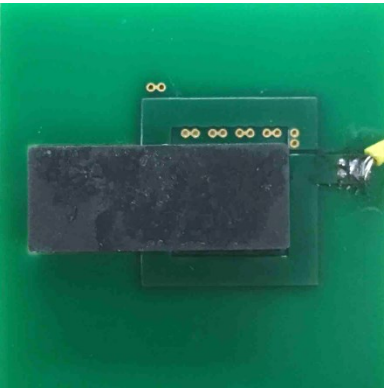


Agree with the predicted based on magnetic moment theory

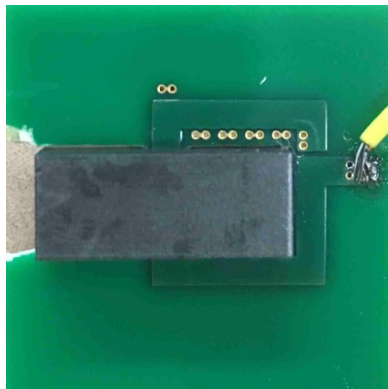
Prototypes

Simulations

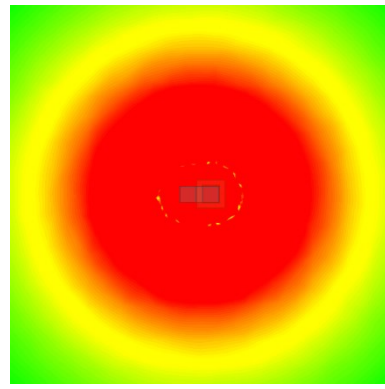
Measurements



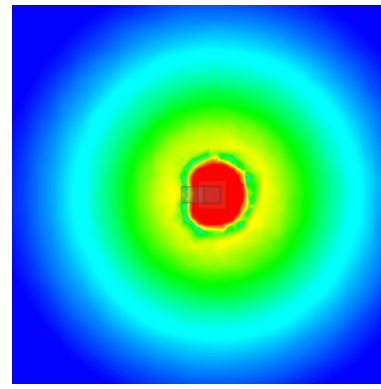
(P1)



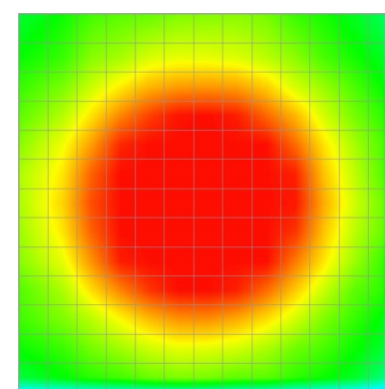
(P4)



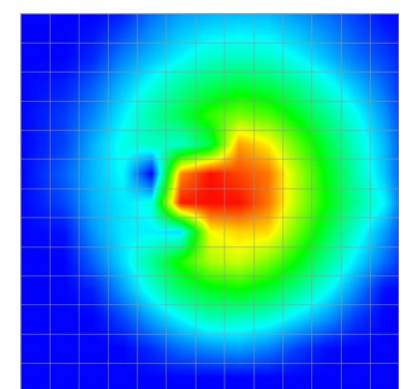
(P1)



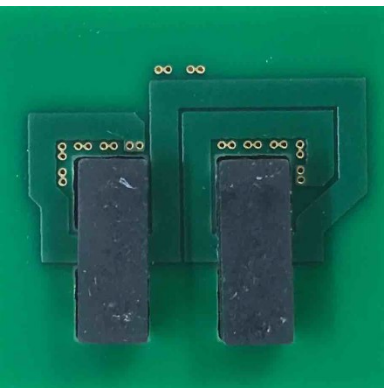
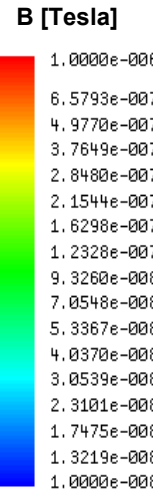
(P4)



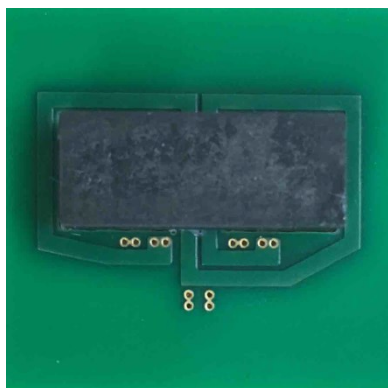
(P1)



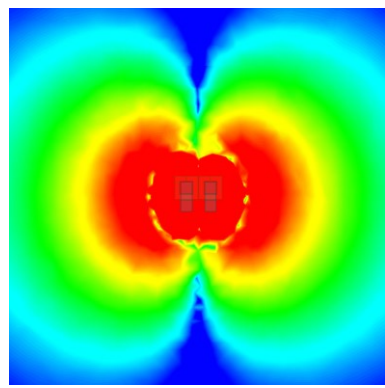
(P4)



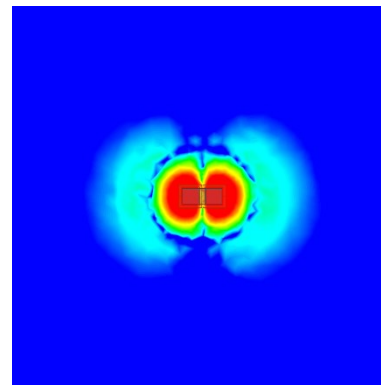
(F5)



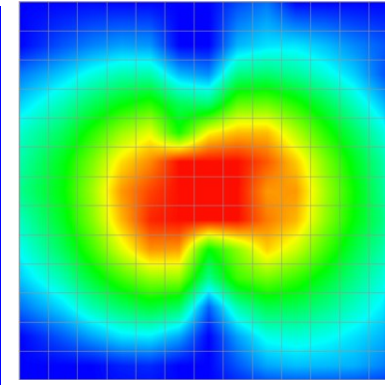
(F2)



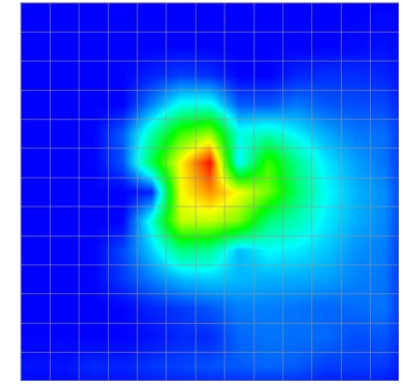
(F5)



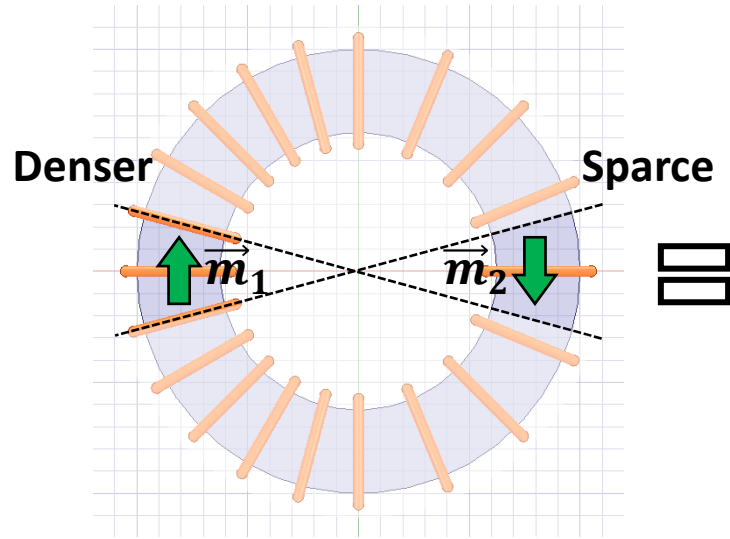
(F2)



(F5)

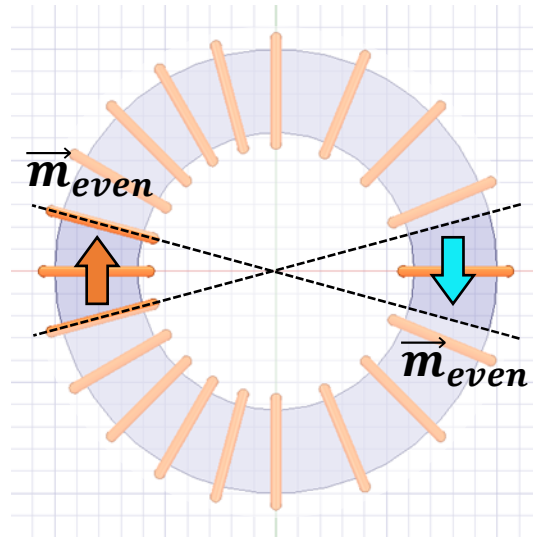


(F2)



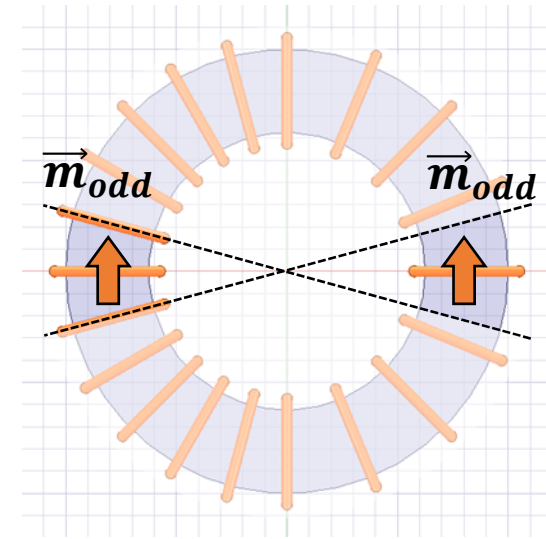
When turns are uneven,
 $|\vec{m}_1| \neq |\vec{m}_2|$

Denser side has larger \vec{m} .



$$|\vec{m}_{even}| = \frac{|\vec{m}_1| + |\vec{m}_2|}{2}$$

**Opposite polarity but
same magnitude.**

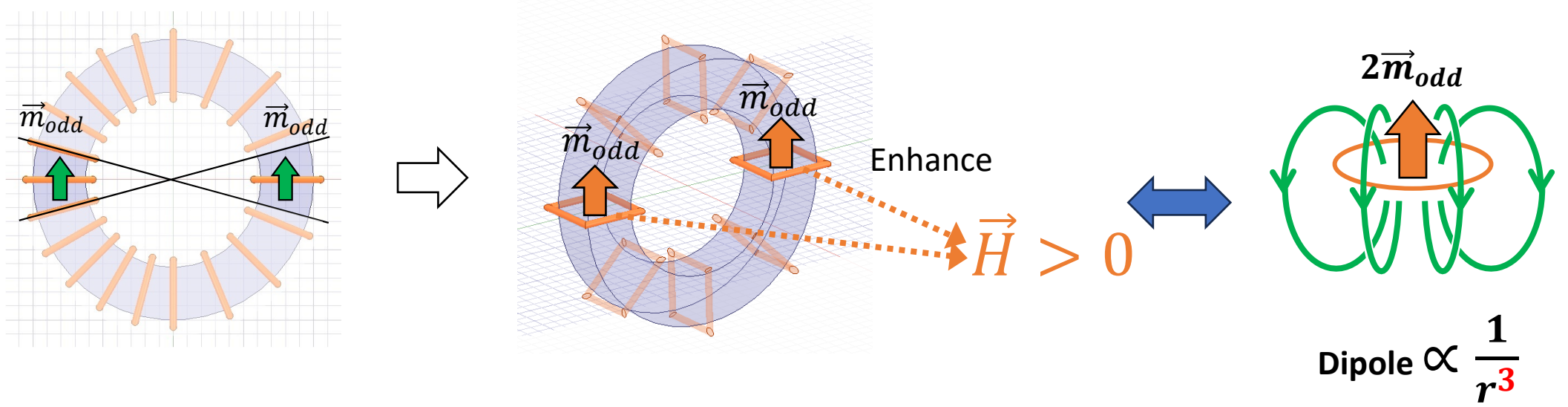
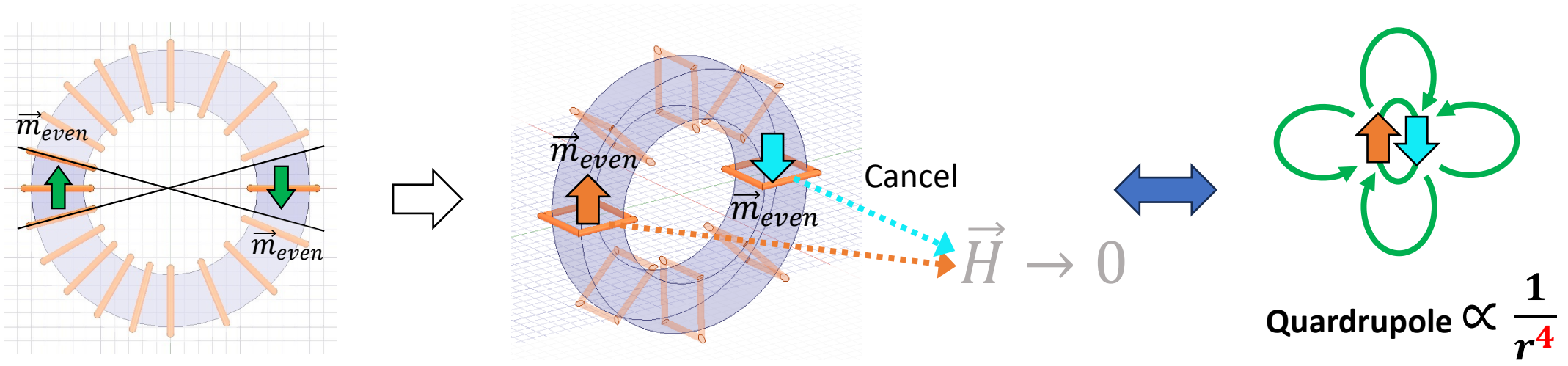


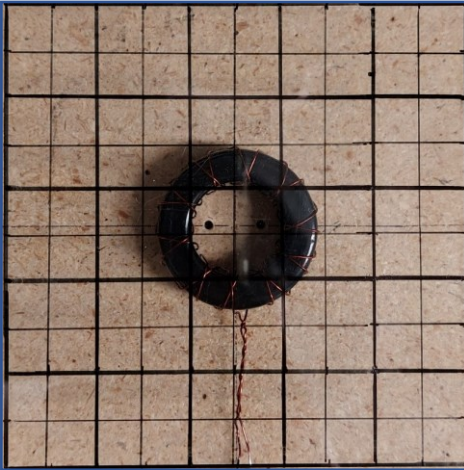
$$|\vec{m}_{odd}| = \frac{|\vec{m}_1| - |\vec{m}_2|}{2}$$

**Same polarity and
magnitude.**

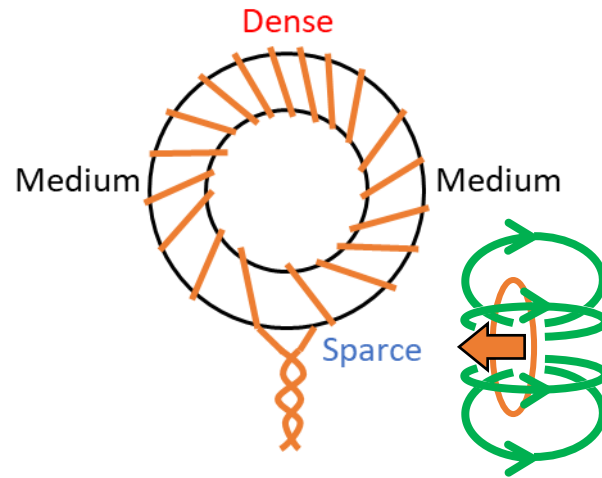
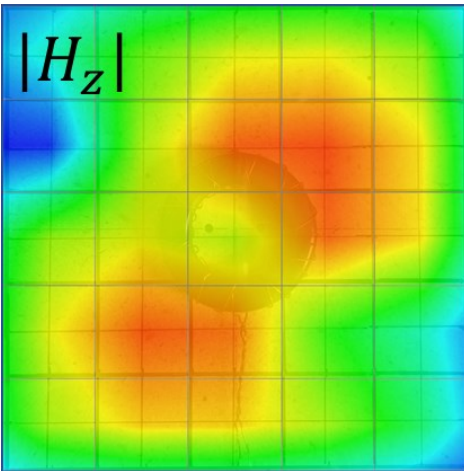
The uneven distribution of turns contribute to near magnetic field emission.

Reference: Y. Yang and S. Wang, "Analysis and Modeling of the Near Magnetic Field Distribution of Toroidal Inductors," in Proc. *IEEE International Symposium of Electromagnetic Compatibility, Signal Integration and Power Integration*, 2023.

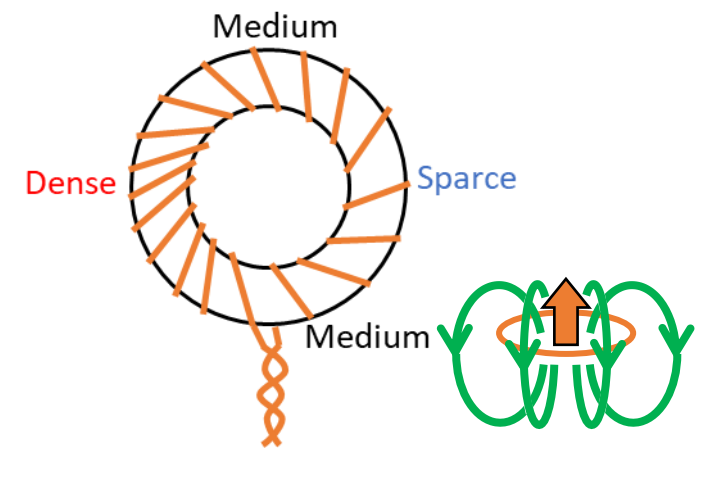
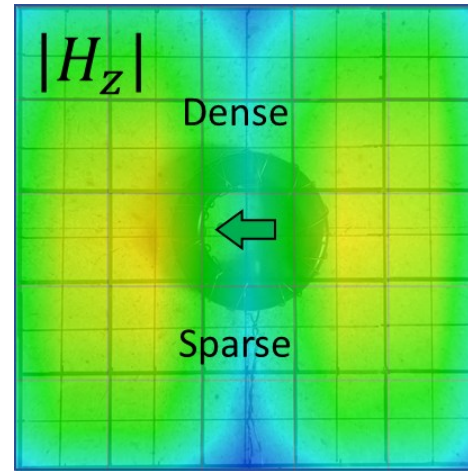




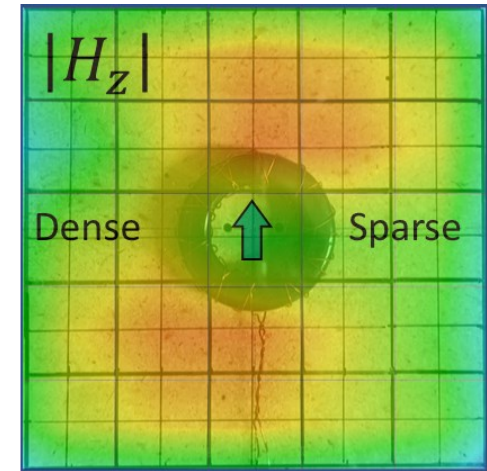
Before adjustment

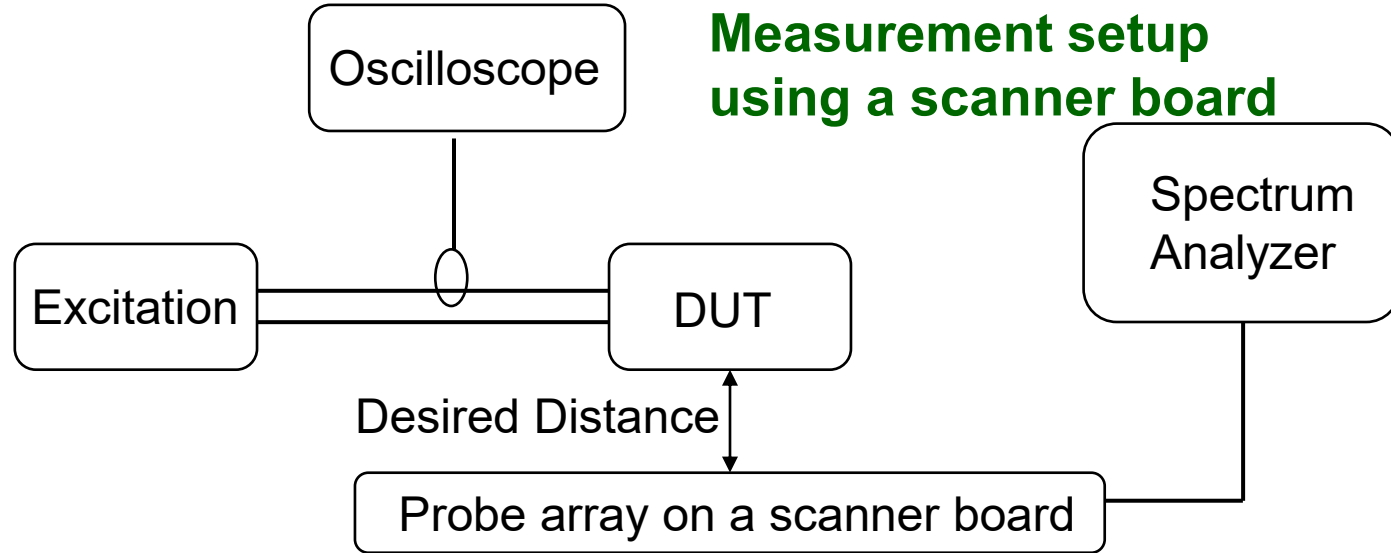


Adjust winding density 1

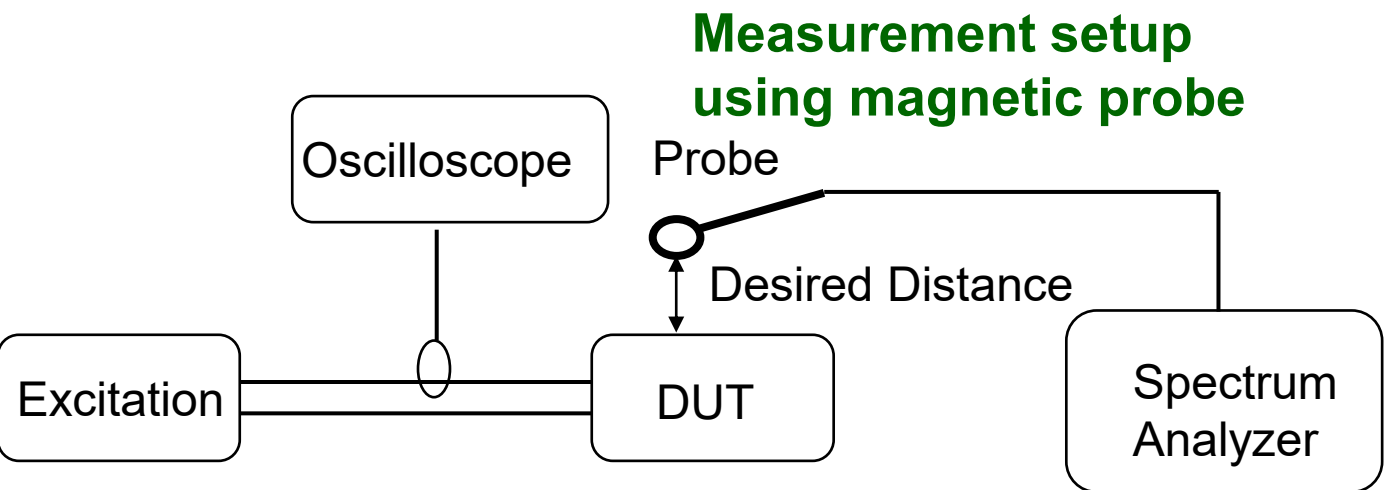


Adjust winding density 2

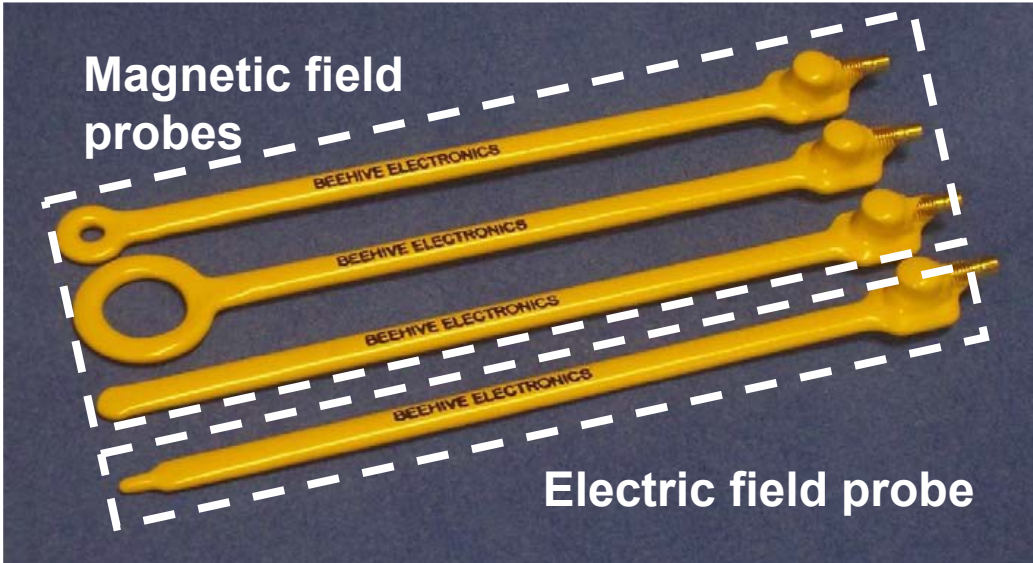




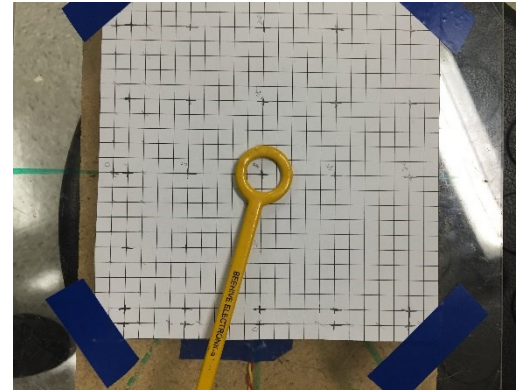
DUT: Device, circuit or components under test
Excitation: Power supply, voltage or current source to provide excitations to DUT
Oscilloscope: Monitor the excitations
Desired distance: The desired distance where the near field is measured
Probes: The near magnetic or electric field probes.
Scanner board: Magnetic field scanner board for magnetic field measurement
Spectrum analyzer: Where the measured near field from the probe or board will be processed and displayed
Sensitivities of probes: The probes have limited sensitivities, so low field cannot be measured. Network analyzers can be used to extract small near field couplings.



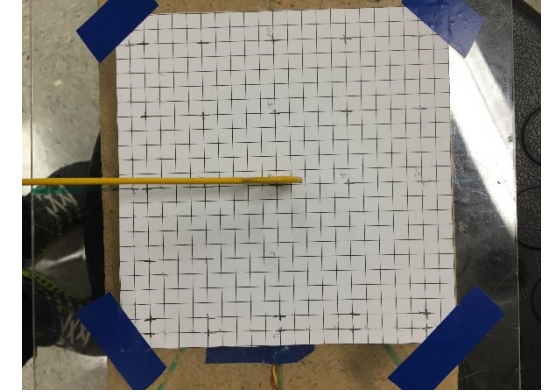
Near Field Probes



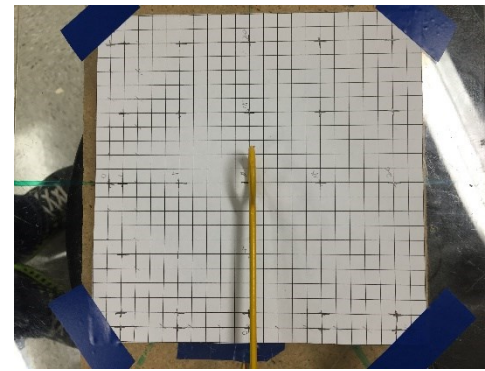
- A probe set has both magnetic and electric field probes
- Different probe loop size provides different spatial resolution
- Bigger probes can measure smaller field but with lower spatial resolution



Measuring Z-direction



Measuring Y-direction



Measuring X-direction

XYZ components of magnetic field should all be measured, then the total magnetic field can be calculated:

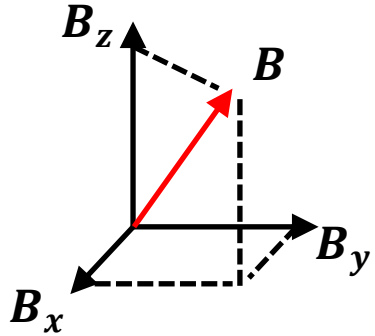
$$H = \sqrt{H_x^2 + H_y^2 + H_z^2}$$

$$\vec{H} = H_x \vec{i} + H_y \vec{j} + H_z \vec{k}$$

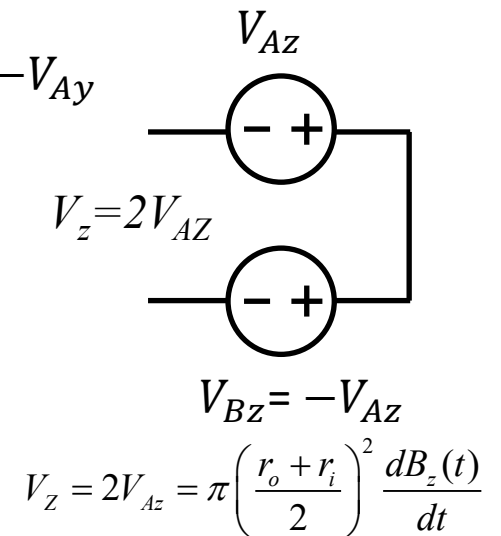
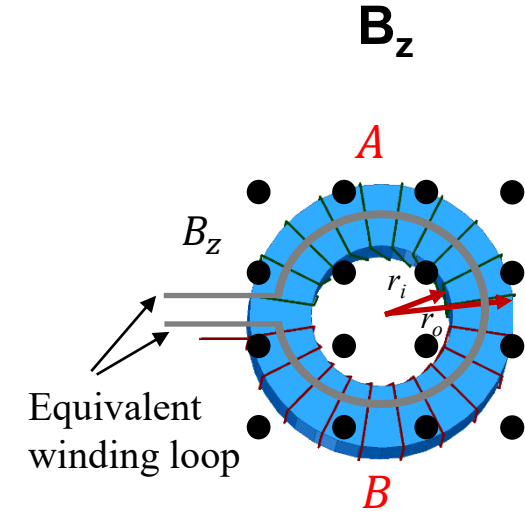
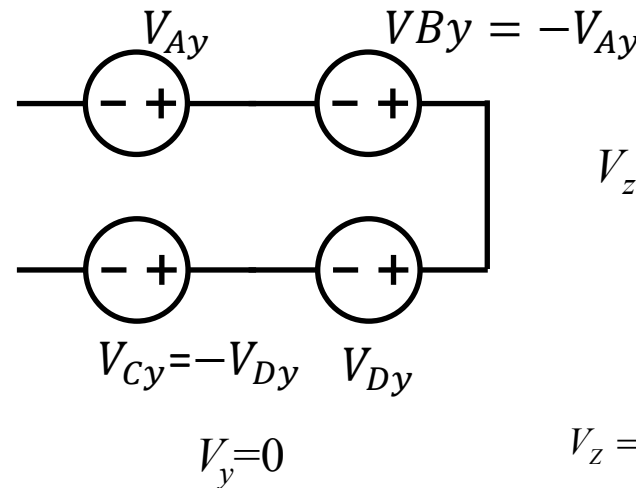
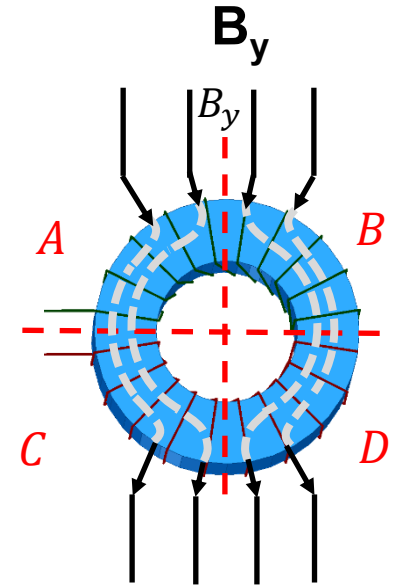
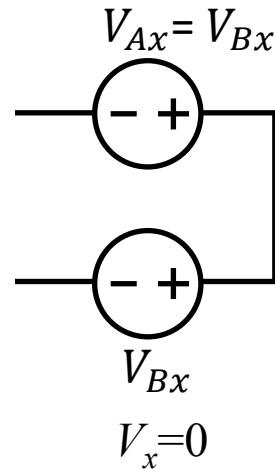
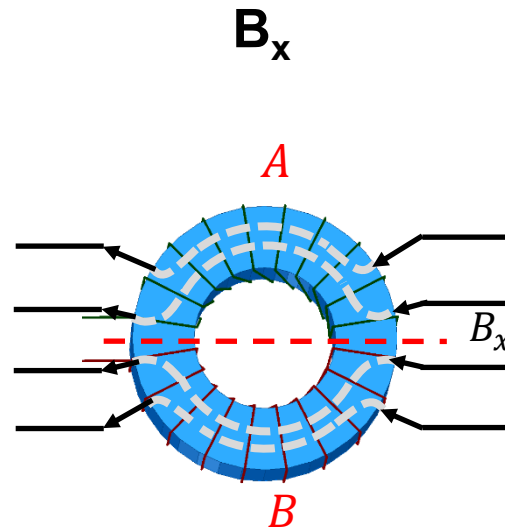
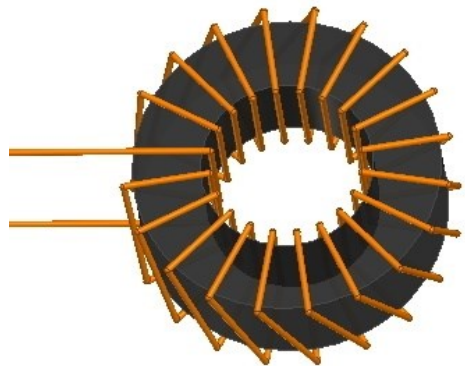
3.3 Power Inductor's Near Field Immunity

Near Magnetic Field Immunity of Power Inductors

External Magnetic Field

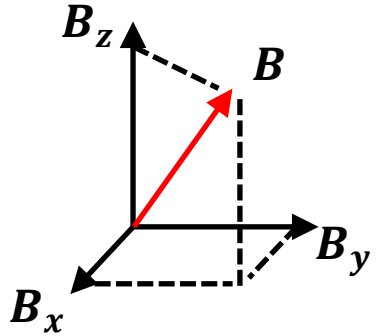


Conventional

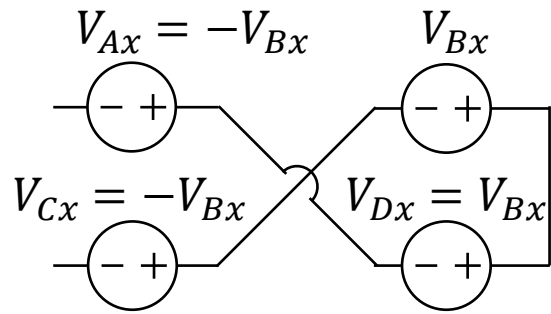
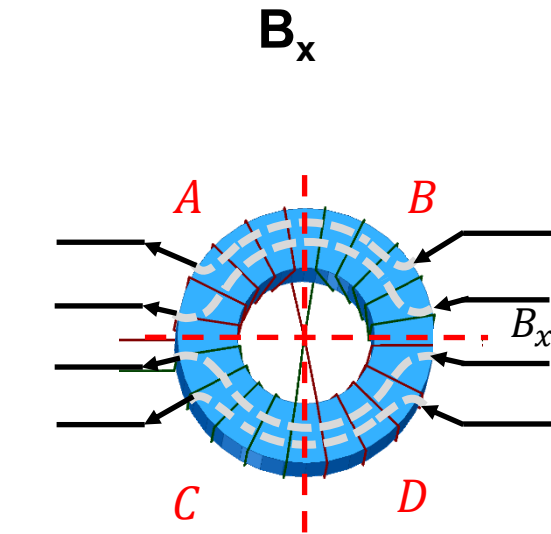
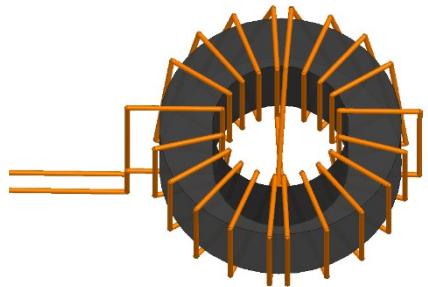


Reference: Y. Lai, S. Wang and B. Zhang, "Investigation of Magnetic Field Immunity and Near Magnetic Field Reduction for the Inductors in High Power Density Design," in *IEEE Transactions on Power Electronics*, vol. 34, no. 6, pp. 5340-5351, June 2019, doi: 10.1109/TPEL.2018.2868646.

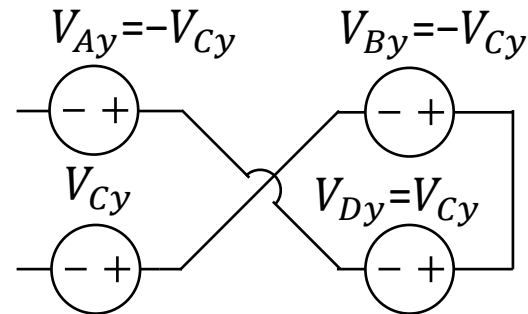
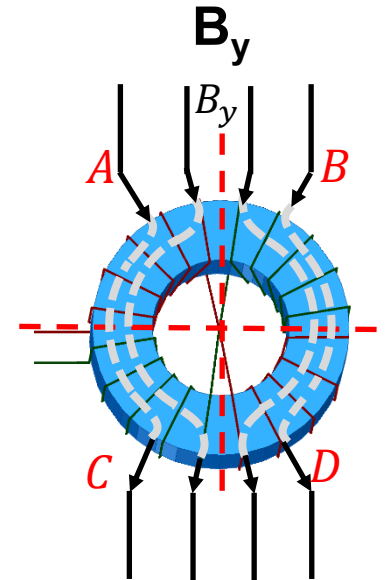
External Magnetic Field



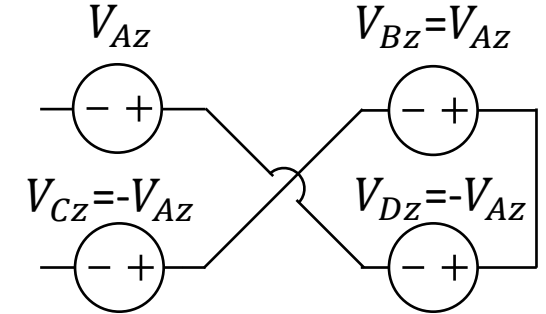
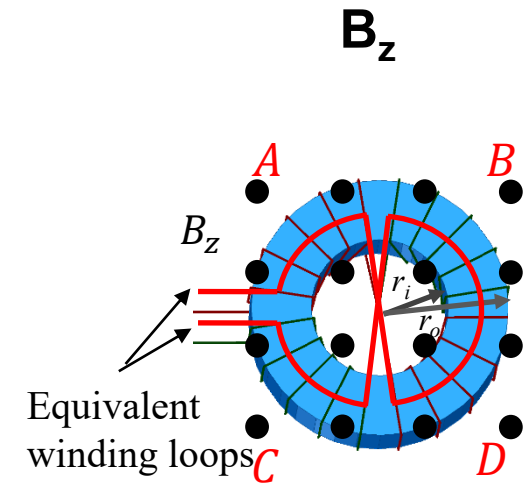
Twisted Winding



$$V_x = 0$$

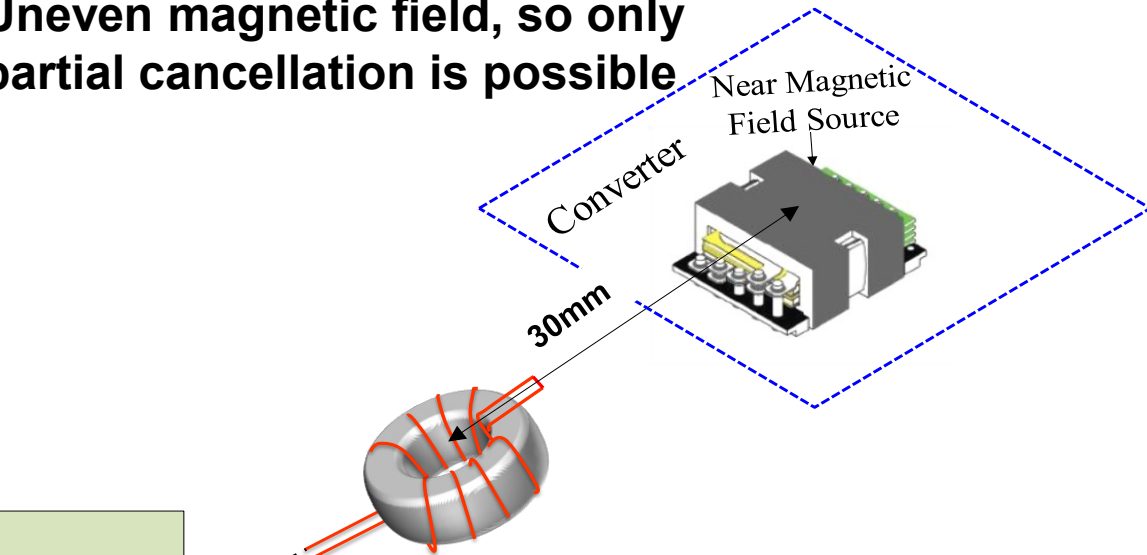


$$V_y = 0$$



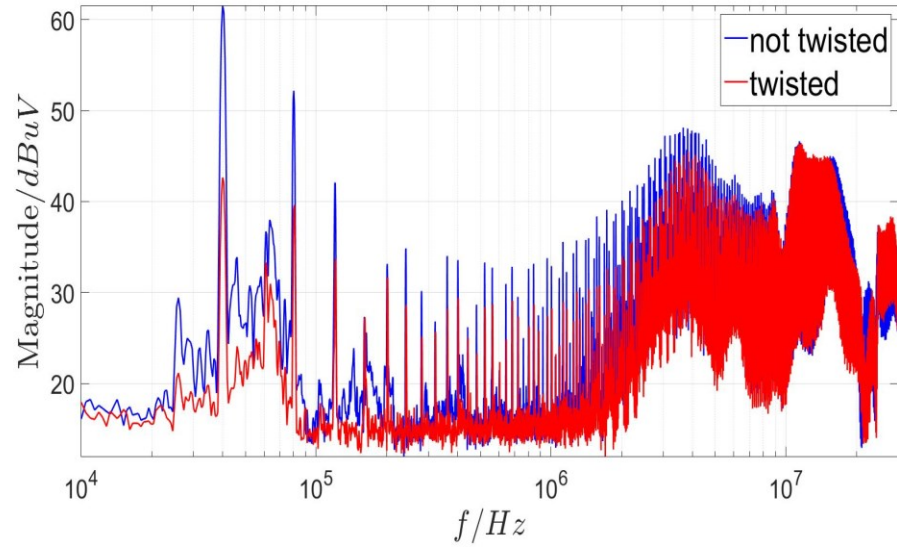
$$V_z = 0$$

Uneven magnetic field, so only partial cancellation is possible

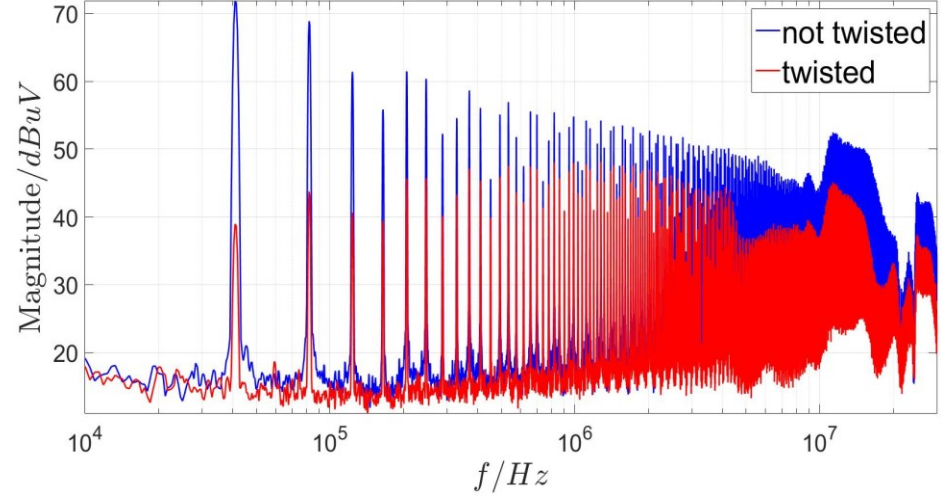


Spectrum analyzer

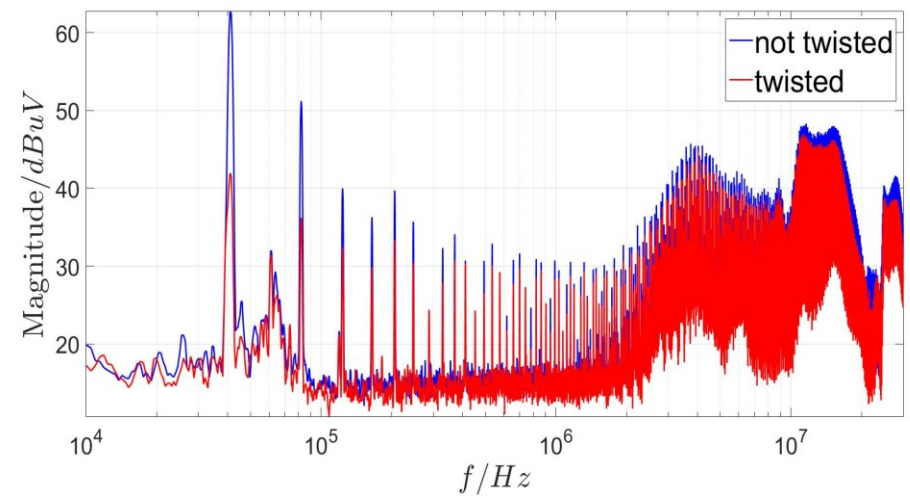
Induced voltages (single-ended L)



Induced CM voltages (CM L)

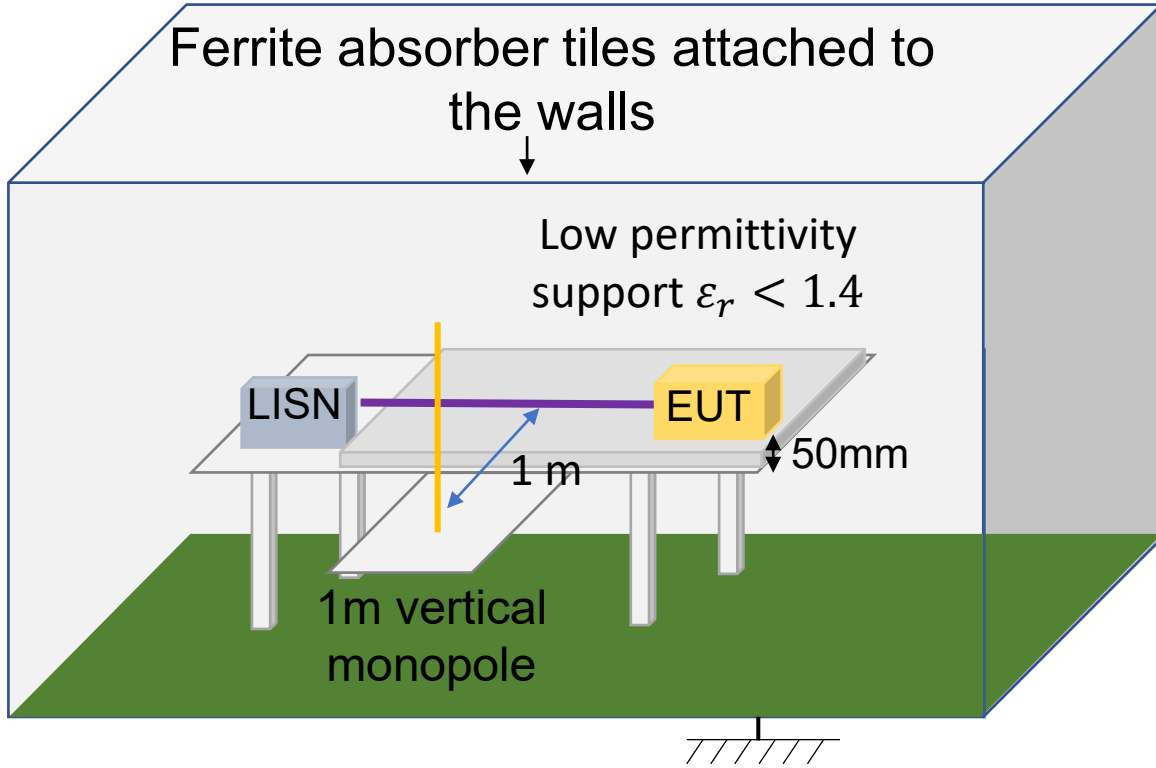


Induced DM voltages (CM L)

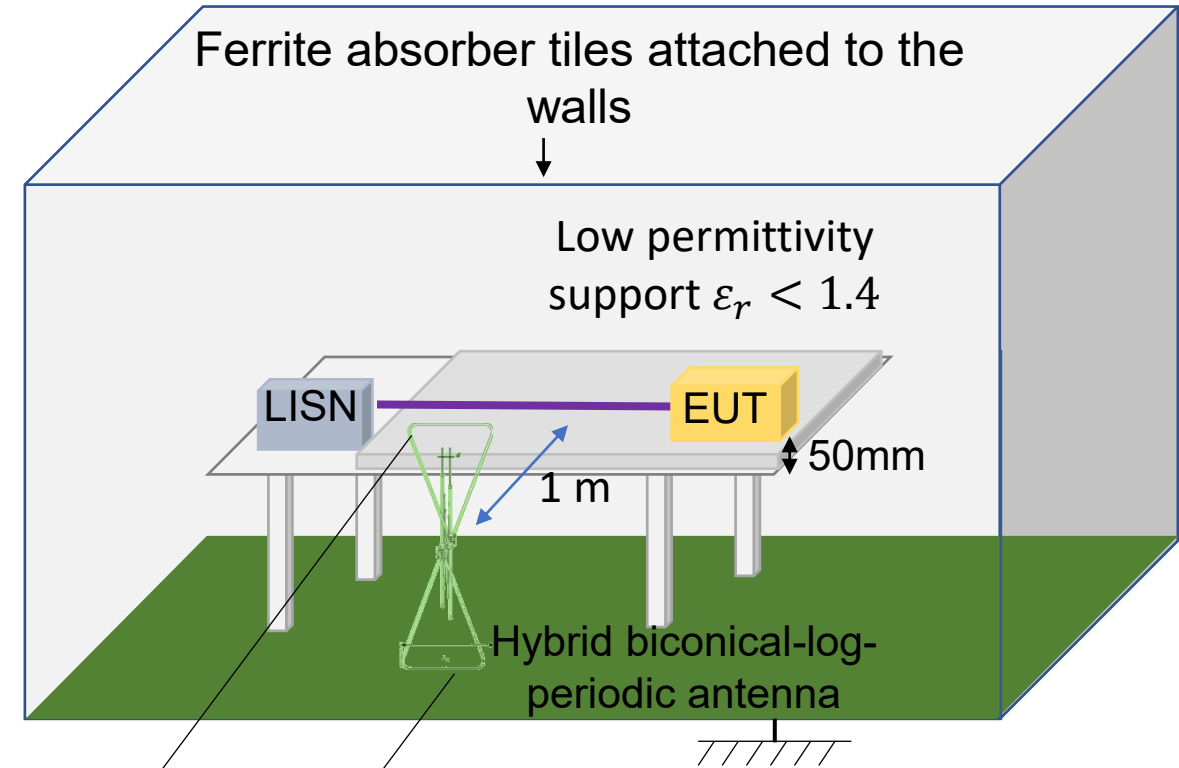


4. Power Inductor's Low-frequency (LF) Radiative Emissions

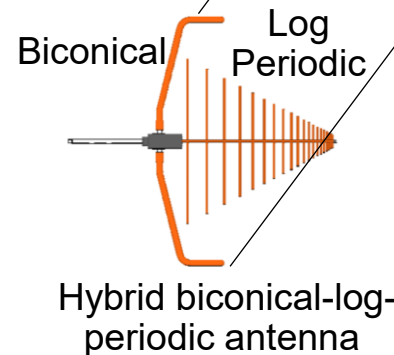
Radiated EMI Measurement in Automotive Applications (CISPR25)



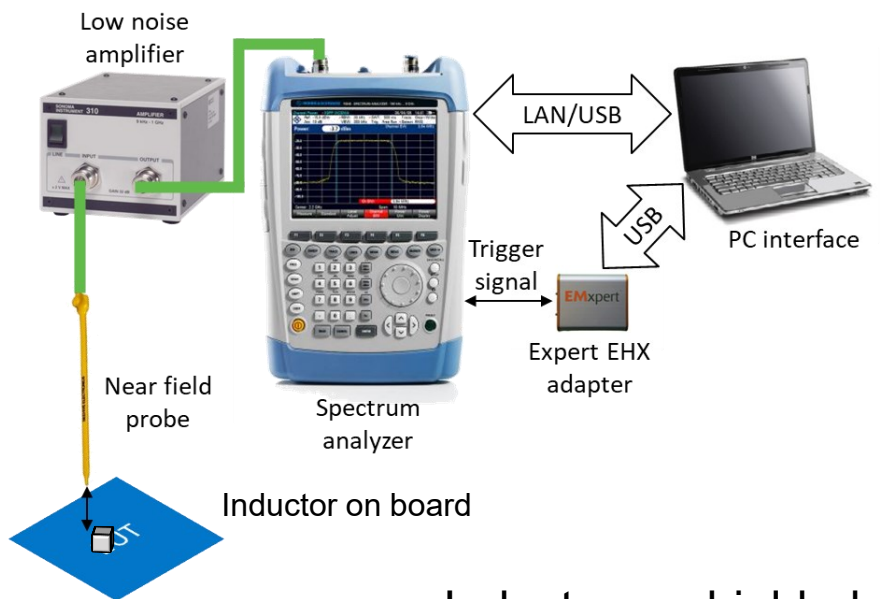
Radiated EMI testing setup (150kHz, 30MHz)



Radiated EMI testing setup (30MHz, 1GHz)

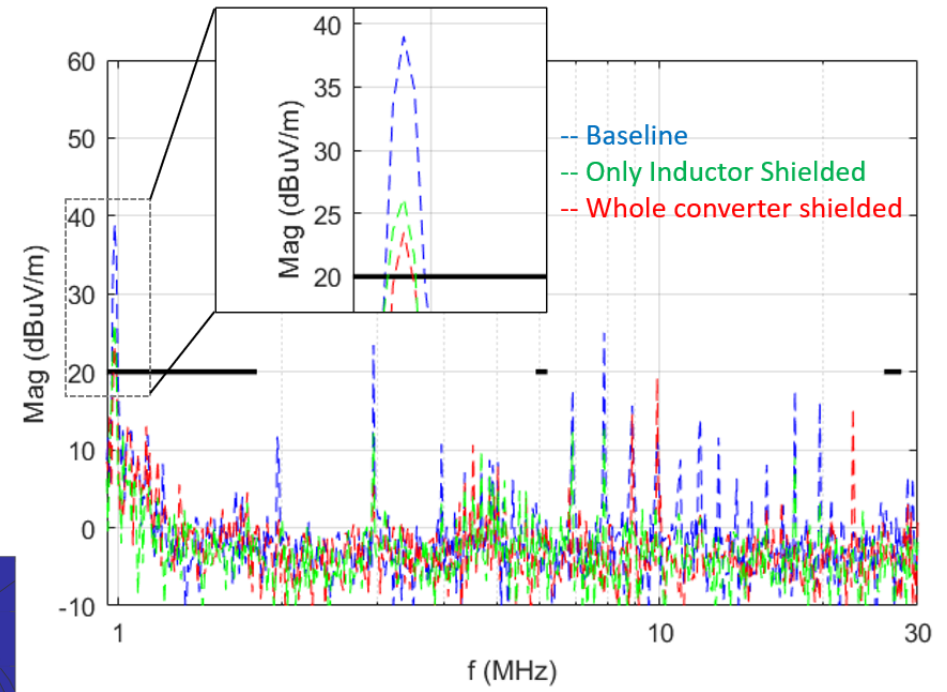


Power Inductors as A Source of LF Radiative EMI

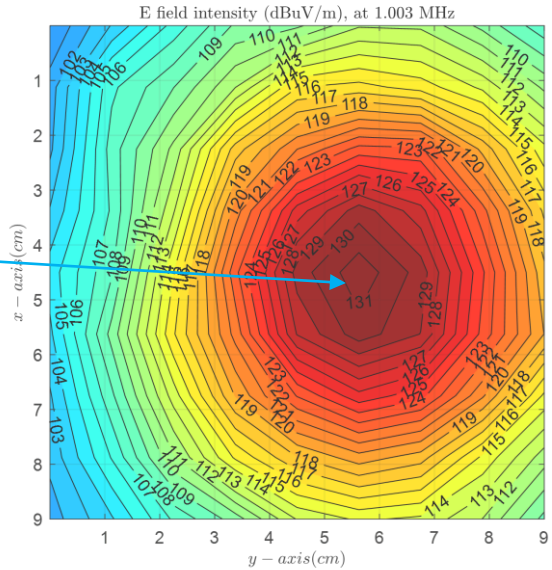


Inductor is a major radiative EMI source below 30MHz

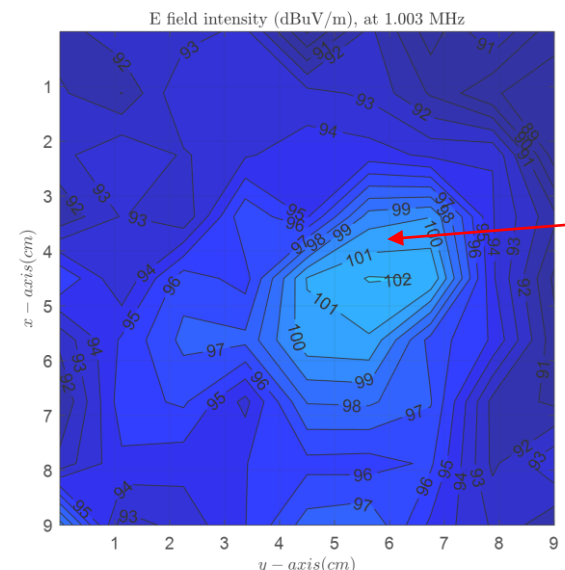
Measured 1-meter radiative emission with a monopole antenna



Inductor unshielded

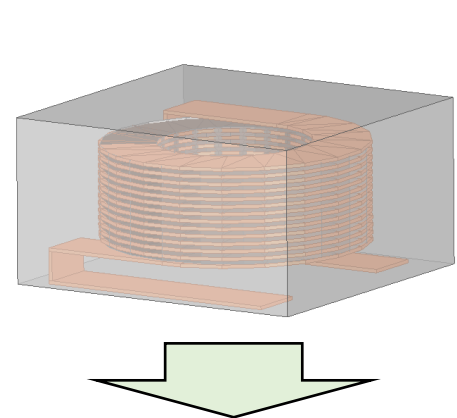


Inductor shielded



Measured Near Electric Field Above the Board @ switching frequency

Decompose Voltage Excitations to CM and DM Voltages



Charge distribution

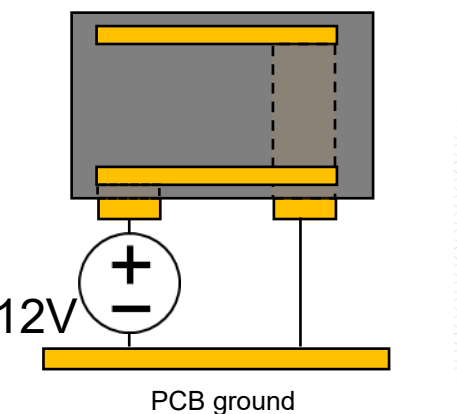
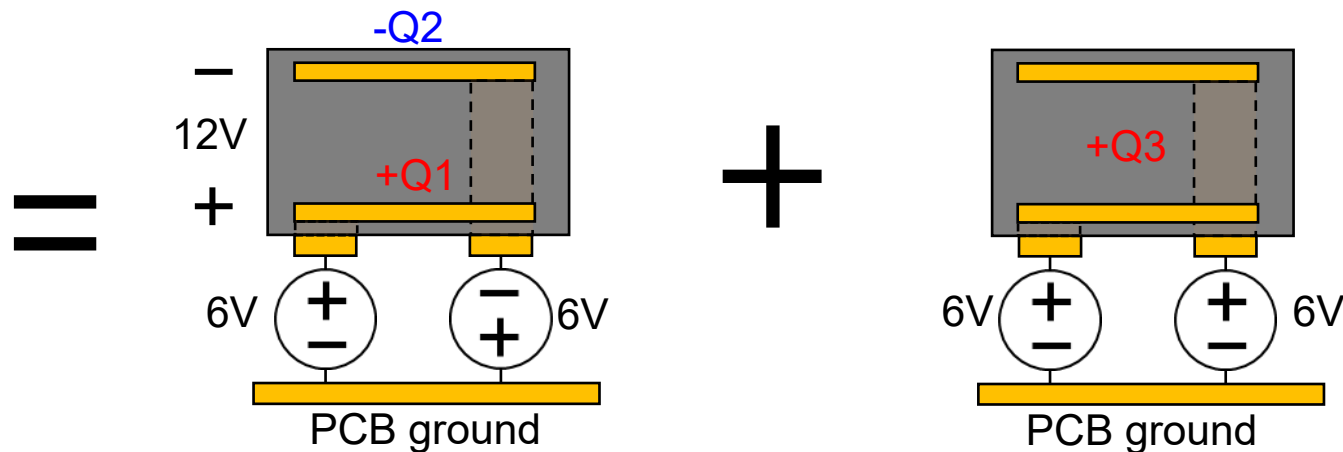
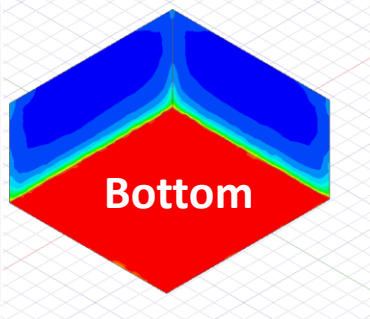
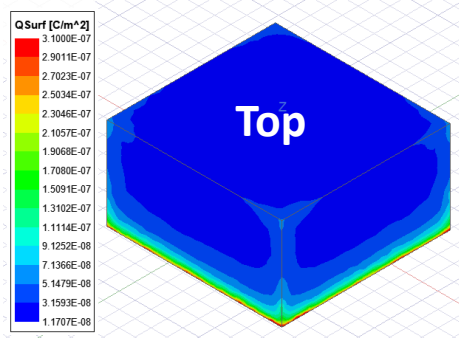
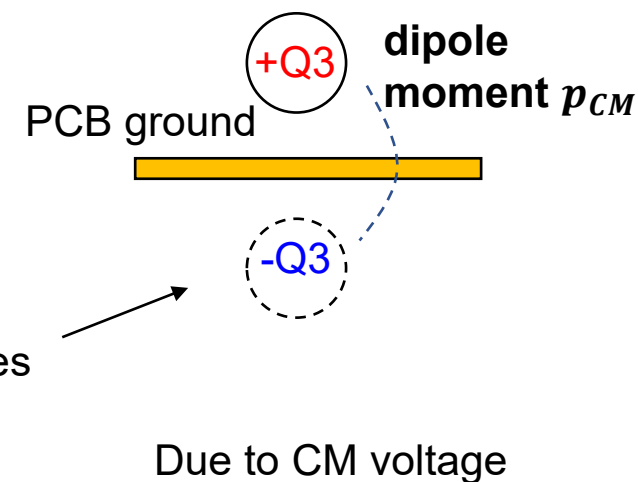
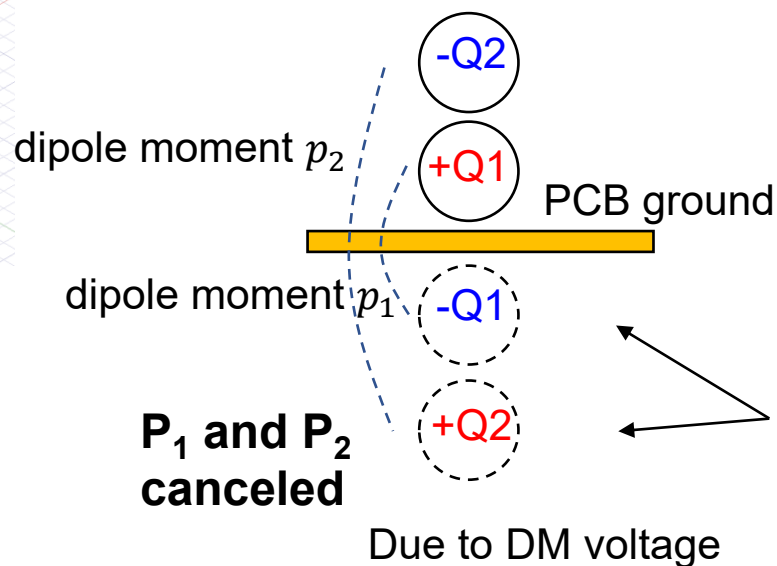
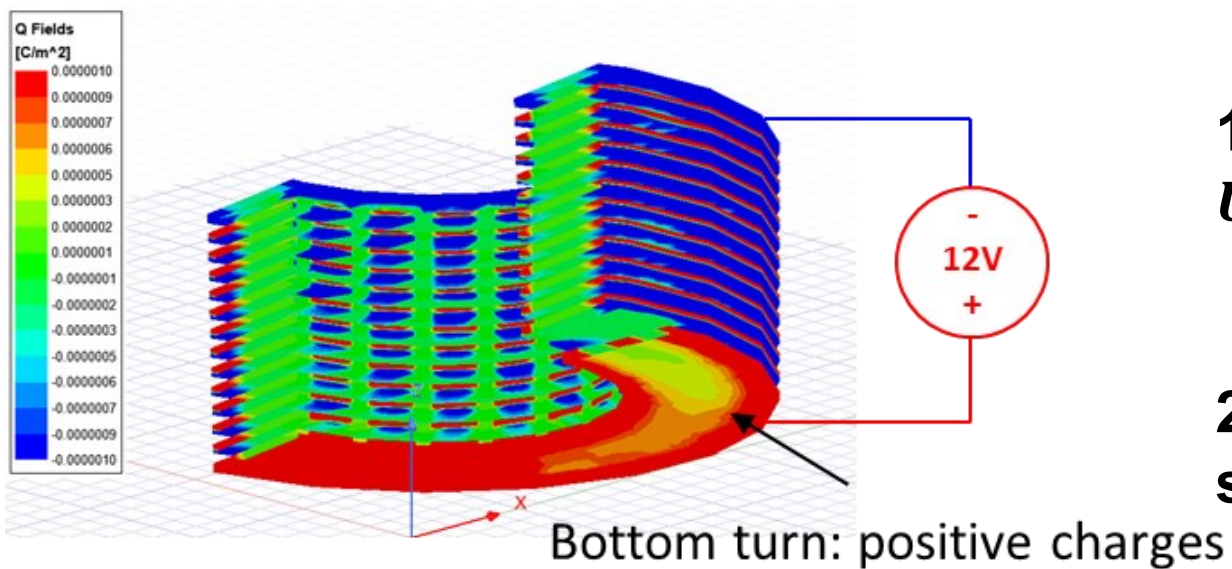
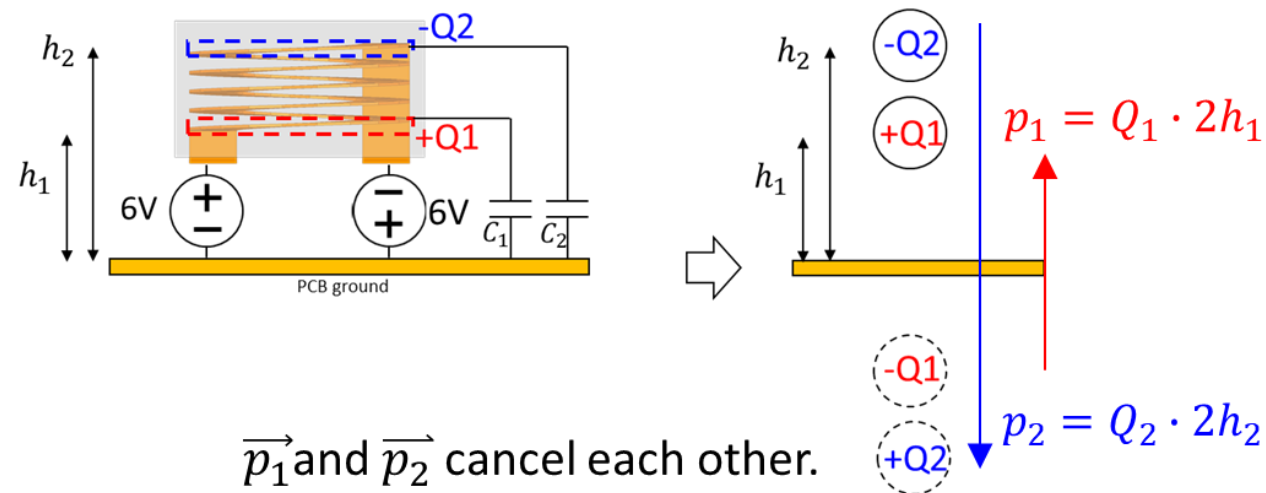
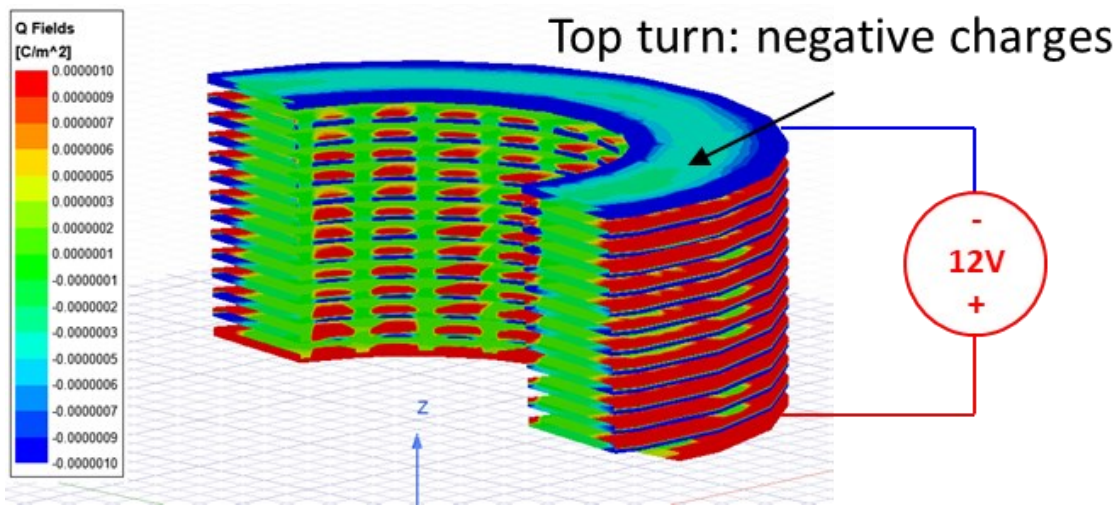


Diagram: An inductor on a PCB





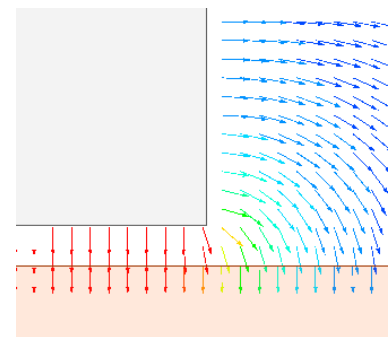
1) The electric moment: $p = Q \times d = C \cdot U \cdot 2h$. The analysis shows that

$$C_1 h_1 \approx C_2 h_2$$

$\Rightarrow \vec{p}_1$ and \vec{p}_2 can cancel each other.

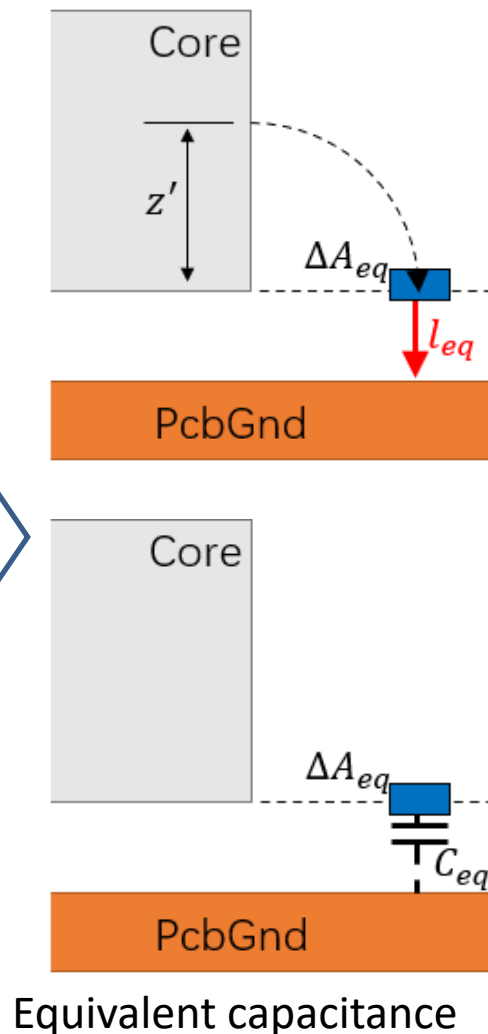
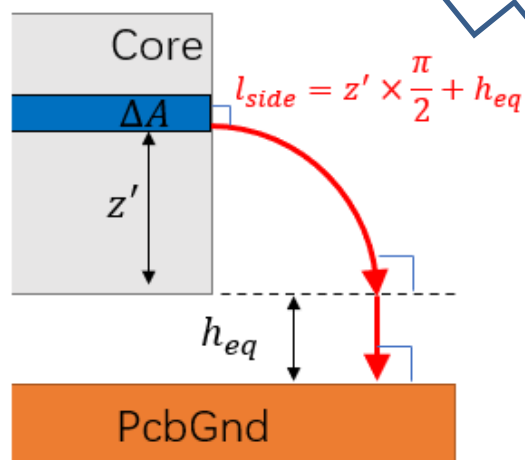
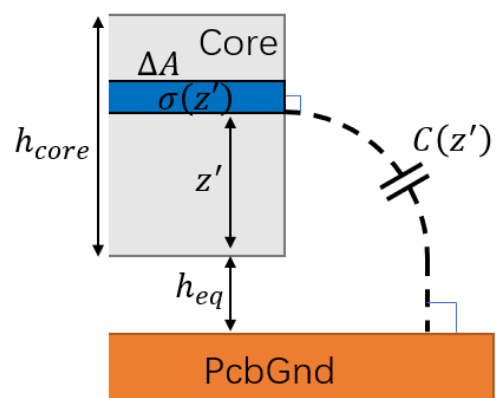
2) Other symmetric pairs have the same story.

Equate All CM Charges to the Bottom Surface w/o Change Original Dipole Moments

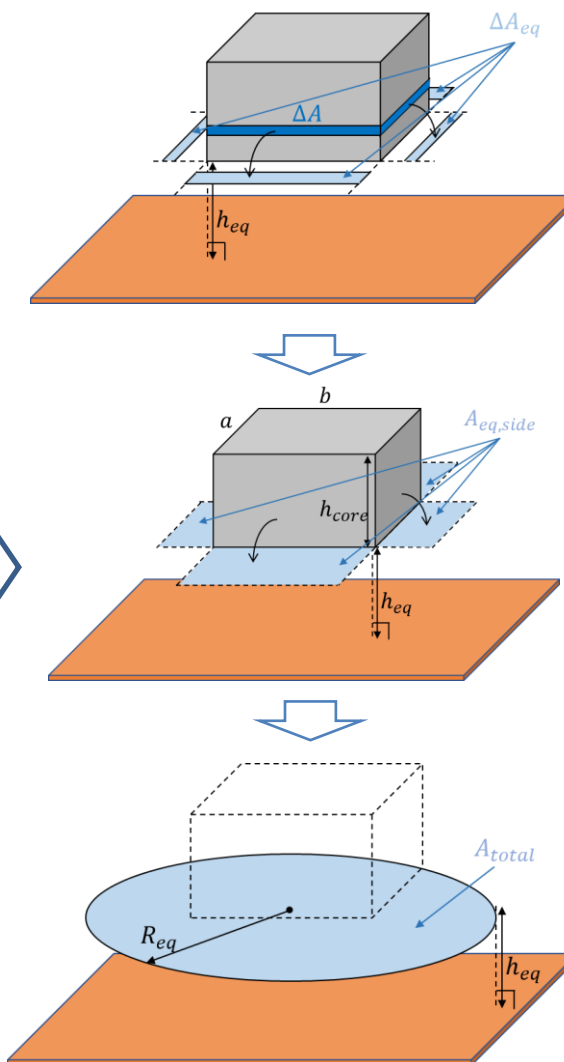


Simulation: electric field distribution

Side surface elements and its capacitance



Equivalent capacitance



Area conversion of core side surfaces

The electric field due to the dipole moment P_{CM} in the space under spherical coordinate :

$$E_r = \frac{p_{CM} \cos \theta}{2\pi\epsilon_0 r^3}$$

$$E_\theta = \frac{p_{CM} \sin \theta}{4\pi\epsilon_0 r^3}$$

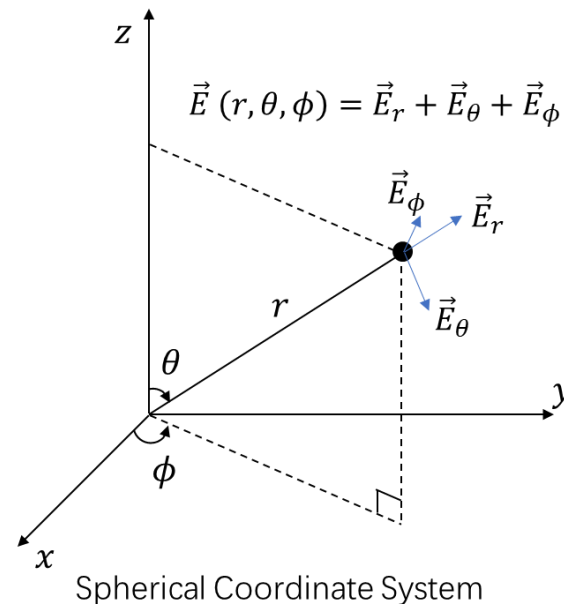
$$E_\phi = 0$$



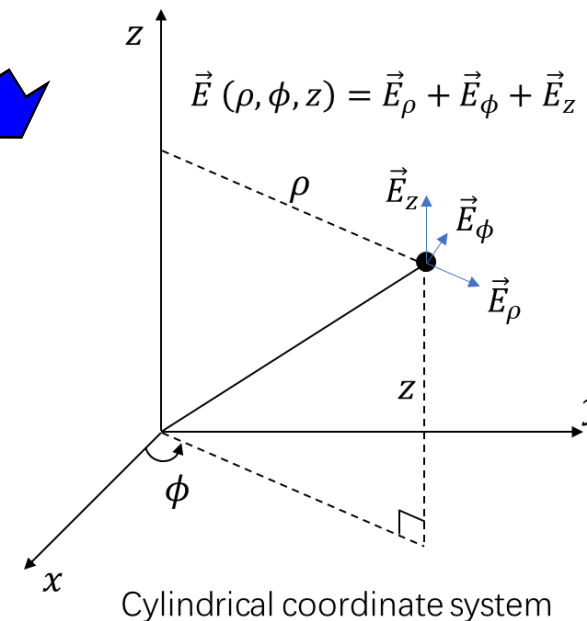
Coordinate transformation

Cylindrical coordinate for z direction E-field prediction

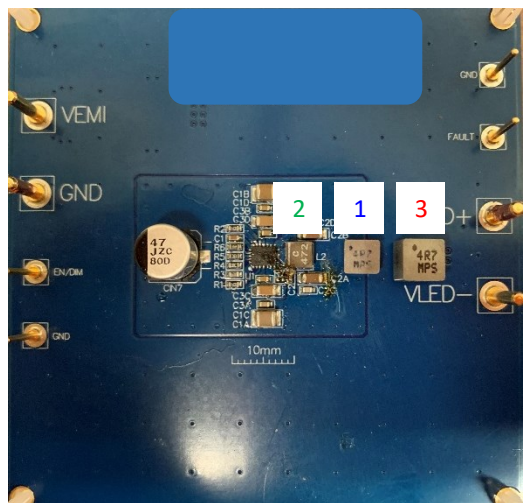
$$E_z = E_r \cos \theta - E_\theta \sin \theta = \frac{p_{CM}}{2\pi\epsilon_0 r^3} \left(\cos^2 \theta - \frac{1}{2} \sin^2 \theta \right)$$



Reference: Y. Lai, Y. Yang, S. Wang and Z. Luo, "A Novel Low-Frequency Radiated Emissions Prediction Technique for the Inductor of a Non-Isolated Power Converter," *2022 IEEE Energy Conversion Congress and Exposition (ECCE)*, Detroit, MI, USA, 2022, pp. 1-8



Experimental Verification of Proposed Prediction Techniques (1-meter Semi-anechoic Chamber)



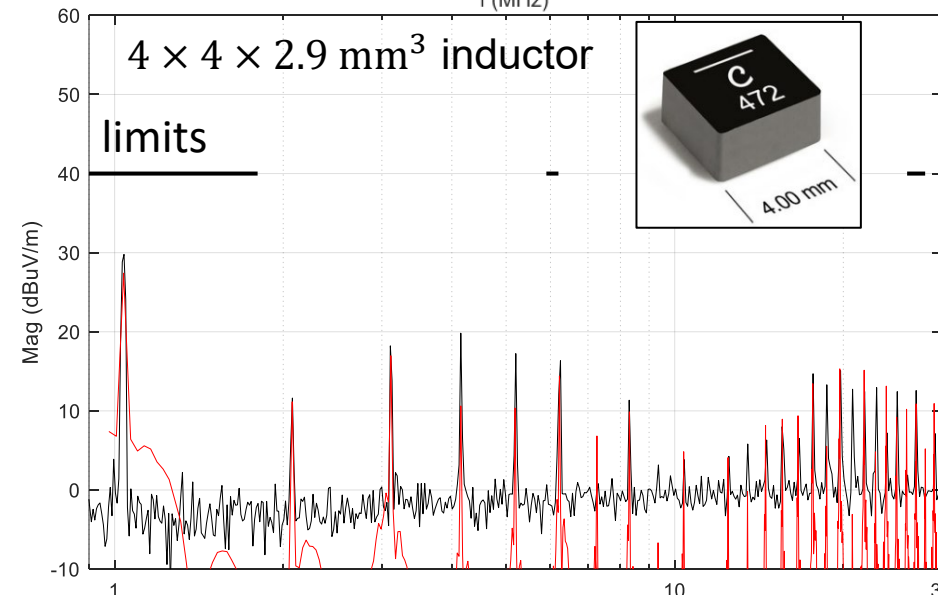
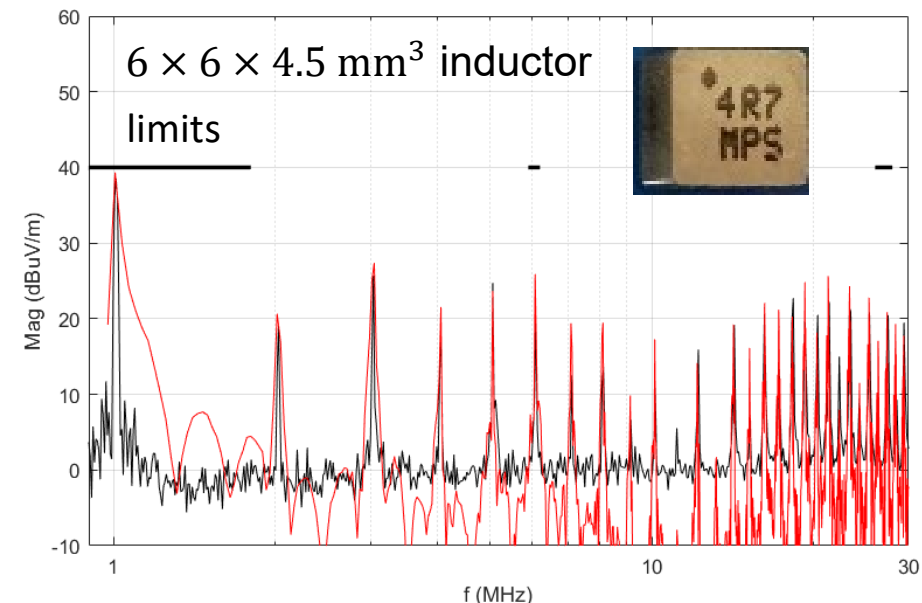
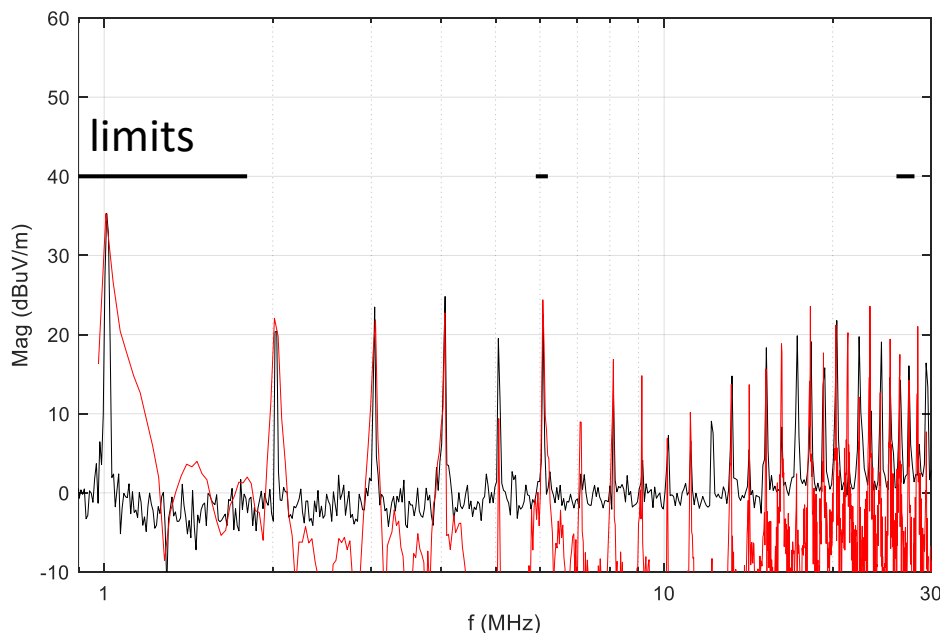
3 inductors are investigated in experiment:

1. $5 \times 5 \times 2.9 \text{ mm}^3$ (Baseline)

2. $4 \times 4 \times 2.9 \text{ mm}^3$

3. $6 \times 6 \times 4.5 \text{ mm}^3$

(Impacts of the chamber setup has been considered in the prediction).



1. Reduce electric dipole P_{CM} can reduce the radiative EMI
2. Smaller inductors have smaller P_{CM}
3. Shorter inductors have smaller P_{CM}
4. Smaller distance between the PCB ground and the inductor leads to smaller P_{CM}
5. Smaller voltages across inductors have smaller P_{CM}

Questions & Answers